Journal of Luminescence Simulation of Optical behavior of YAG:Ce 3+ @SiO2 phosphor used for chip scale packages WLED --Manuscript Draft--

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Abstract:	YAG:Ce 3+ yellow phosphor are particularly used luminescent materials to produce white light in phosphor-converted white LED (pcW-LED). Surface coating of YAG phosphor is the main concern for desired optical performance of the phosphors. Many scholars conducted various experimental analysis on the surface coating of phosphors to improve yellow emission, but the theoretical explanation by which phosphor coating could help improving light efficiency has not yet been studied. In this paper, based on Mie theory, the optical constants such as scattering coefficient, absorption coefficient and asymmetry parameter of YAG:Ce 3+ phosphor and YAG@SiO 2 (YAG:Ce 3+ phosphor surface coated with nano-SiO 2 layer) were calculated. An optical configuration of chip scale packages (CSP) WLED was constructed by coupling YAG:Ce 3+ or YAG@SiO 2 phosphors with a LED laser. Based on the optical parameters calculated by Mie theory, the luminescent properties of YAG:Ce 3+ and YAG@SiO 2 WLED were simulated by Monte Carlo method. The results showed that a thin SiO 2 coating layer on YAG phosphor result in an overall increase in luminous performances compared with original YAG WLED. The absorption coefficient of phosphor is the main concern affecting the light emission in WLED. Due to the fact that YAG@SiO 2 pubsess higher , it could absorb more blue light than YAG, thereby it has a 1.2% higher conversion efficiency than YAG, finally the enhanced luminous efficiency of YAG@SiO 2 WLED is obtained. The results obtained in this work provides a potential method in future WLED packaging designing.		
Response to Reviewers:	Dear Editors, On behalf of my co-authors, we appreciate you and reviewers very much for your positive and constructive comments and suggestions. Thank you very much for your supervision of the reviewing process of our manuscript entitled "Simulation of Optical behavior of YAG:Ce3+ @SiO2 phosphor used for chip scale packages WLED" (Manuscript ID LUMIN-D-21-01164). We also highly appreciate the reviewer's carefulness, conscientious, and the broad knowledge on the relevant research fields, since they have given us a number of beneficial suggestions. According to the reviewer's comments, we have studied carefully and have made the following revisions (Note: The changes in the revised manuscript had been highlighted by yellow background): Response to the reviewer #1 :		

Comment 1: Some details in the manuscript need attention. In Figure 7, (a), (b), (d) horizontal and vertical scales are inward, and (c) horizontal and vertical scales are outward.

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Response: Thank you for your constructive advice. We agree with your point that highpower LED and LD will become the mainstream in the future. For LD lighting, the cost of lasers is high and they are susceptible to environmental influences such as temperature, which will cause the light quality to decrease High-power LED mostly use glass or transparent ceramic substrates. For glass substrates, there will be diffusion problems, at high temperatures, silicon element of low temperature glass can vulnerably diffuse into phosphor particle resulting in drop in fluorescence emission intensity. This diffusion problem can be prevented if one diffusion barrier layer coated on phosphor particle surface, such as called sol-gel Ce3+:YAG doping glass。 Therefore, our work could be also used for coated phosphor in high-power LEDs. At mean time, our research still has some practical value to a certain extent. Firstly, YAG phosphor has low raw material prices, simple synthesis process, convenient preparation. the Chip Scale Package(CSP) technology have become one of the biggest packaging trends in recent history. It enables direct attach, can withstand higher stress, is intrinsically robust to external handling, and comes at a lower cost. It can be widely used in backlight, health inspection and car headlights, garden lighting, etc. YAG phosphor has been used in several Samsung CSP WLED. In the CSP WLED, a blue light LED chip is usually covered with a layer of yellow fluorescent film to generate white light. It is changing the LED industry pattern, especially its supply chain. CSP LED is suitable to meet the lighting requirements such as high power and high brightness, etc. Secondly, in view of the foregoing results, we hold the opinion that this method can be extended to other coating phosphor systems and it is helpful to decrease the amount of experiments significantly. Luminescent core-shell structures appear to be very promising and are now becoming more popular in different applications. Core-shell structures show superior physical and chemical properties in comparison with their single-component counterparts, making them attractive choices for a wide range of applications not only in solid state lighting, but also in biomedicine, energy conversion, storage, and catalysis.

Comment 3: In the article, YAG LEE is 132.11 lm/W, and YAG@SiO2 LEE is 138.92 lm/W, these data are not sufficiently advantageous.

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Comment 4: In practical application, the thermal quenching of WLED phosphors is inevitable, which is not mentioned in this paper.

Response: We very much agree with your point that thermal quenching is inevitable, and there are some investigations showing us that SiO2-coated YAG can effectively reduce thermal quenching (see the reference[16], [17]). For thermal quenching phenomenon, both light and heat simulations are required, your suggestion did give us a new thinking. It must be a very meaningful study and we are also very interested. we would like to explain it in detail in a follow-up article. Thank you again for your advice.

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Sincerely yours, Corresponding author: Xinqing Su E-mail: sxg_msc@nuaa.edu.cn

Dear Editor,

We would like to submit a manuscript entitled <u>"Simulation of Optical behavior of</u> <u>YAG:Ce3+@SiO₂ phosphor used for chip scale packages WLED</u>", which we wish to be considered for publication in <u>Journal of Luminescence</u>.

Many scholars conducted experimental analysis on phosphor coating, the theoretical explanation by which phosphor coating could help improving light efficiency has not yet been studied.

In this paper, the YAG:Ce³⁺ and YAG phosphor coated with SiO₂ layer(YAG@SiO₂) were chosen as the optical stimulation target. Firstly, consider the **YAG and YAG@SiO₂ phosphor** as spheres, the optical constants of these two phosphors were calculated based on **Mie theory**. Secondly, based on the optical constants of YAG and YAG@SiO₂ phosphor obtained, the luminescence performances of YAG and YAG@SiO₂ CSP WLED were simulated based on Monte Carlo method. Thirdly, in view of the foregoing results, we hold the opinion that this method can be extended to other coating layers and phosphor systems and it is helpful to decrease the amount of experiments significantly.

We hope that our manuscript meets the high standards of your journal. We are looking forward to your reply!

Sincerely yours,

Prof. Xinqing Su

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Fig. s1 Chip-scale packaged LED products (a) LM101B; (b) LH181A; (c) C020_CSP

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Highlights:

Many scholars conducted experimental analysis on phosphor coating, the theoretical explanation by which phosphor coating could help improving light efficiency has not yet been studied. In this paper

- 1. the optical constants of YAG phosphor and YAG@SiO₂ (YAG surface coated with nano-SiO₂ layer) were calculated based on Mie theory
- 2. the luminescence performances of YAG and YAG@SiO₂ CSP WLED were simulated, the results showed that the absorption coefficient of phosphor is the main concern affecting the light emission in WLED.

Simulation of Optical behavior of YAG:Ce³⁺@SiO₂ phosphor used for chip scale packages WLED

Yahui Shi¹, Xinqing Su¹*, Haitao Zhu², Renli Fu¹, Qinjiang He¹, Min Zhu¹, Haidong Ren³*

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Abstract:

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Key words: YAG:Ce³⁺ phosphor; YAG@SiO₂; Mie scattering; luminous efficiency.

1. Introduction

White lighting-emitting-diode (WLED) has been widely used in commercial solid lighting applications because of its small size, long life, energy saving, environmentally friendly and high luminous efficiency properties [1, 2]. The most appropriate method to obtain WLED is called phosphor-converted (pc-) WLED. Typically, a pc-WLED is usually fabricated by combining the blue LED chip with YAG:Ce³⁺ phosphors which has acceptable color rendering and robust reliability. Traditionally, a pc-WLED package consists of LED chip, phosphors, lead frame, silicone, substrate and so on [3]. However, more packaging components in WLED package indicate higher failure possibility as well as more space occupation and more weight[4]. The chip scale package (CSP) technology is developed by covering a thin YAG fluorescent film on a blue LED chip, which could tackle this problem. The advantages of CSP WLED are the increased manufacturing efficiency [5, 6], high packing density and high luminous flux output. In the package, refractive index of silica gel (1.41) is lower than that of YAG:Ce³⁺ crystal (1.84) in the thin phosphor film, therefore, more yellow light is absorbed by phosphor particle due to the total internal reflection (TIR), luminous efficiency of the CSP WLED decreases accordingly. At the same time, the refractive index difference between

phosphor and silica gel leads to light scattering at the interface, which also results in the blue light reflection loss and the decrease of luminous efficiency [7]. More recently, some studies try to solve the problem by coating a dielectric layer with suitable refractive index on the phosphor. This refers to coating one or more layers of oxide material on the surface of the phosphor particles, such as TiO_2 [8, 9], Al₂O₃ [10, 11] and SiO₂ [12, 13]. The oxide material coating on the phosphors with matched refractive index could reduce the yellow light absorption by TIR, decrease the blue light reflection loss at the interface, in the end, improve the luminous efficiency of WLED. Among them, SiO₂ is widely used due to its optical transparency, tunable size [14] and low cost [15]. Many scholars conducted experimental analysis on phosphor coating, most of the studies focus on the influence of oxide layer microstructure on the luminous efficiency of WLED evaluated by photoluminescence spectra (PL spectra), but no one go deep into the light efficiency enhancement mechanism investigations. Few researchers seriously considered how the variation of light absorption and scattering of oxide layer coated phosphor affect the light extraction of WLED. Meanwhile, the optical parameters such as scattering coefficient (μ_{sca}), absorption coefficient (μ_{abs}) and anisotropy parameter (μ_{abs}) of the coated phosphors also change as well. Actually, precise optical constants of coated phosphor are indispensable in the numerical simulation of the luminescent property of WLED. However, few research discussed about this, to the best of our knowledge.

In this paper, the YAG:Ce³⁺ and YAG phosphor coated with SiO₂ layer(YAG@SiO₂) were chosen as the optical simulation target. Firstly, consider the YAG and YAG@SiO₂ phosphor as spheres, the optical constants of these two phosphors were calculated based on Mie theory. Secondly, based on the optical constants of YAG and YAG@SiO₂ phosphor obtained, the luminescence performances of YAG and YAG@SiO₂ CSP WLED were simulated based on Monte Carlo method.

Thirdly, in view of the foregoing results, we hold the opinion that this method can be extended to other coating layers and phosphor systems and it is helpful to decrease the amount of experiments significantly.

2. Description of the configuration of CSP WLED

The configuration of CSP WLED is constructed as shown in Fig. 1. In CSP LEDs, blue LED chips are mostly covered with yellow YAG fluorescent film to generate white emission (as shown in Fig.1 (e)). The YAG fluorescent film (as shown in Fig. 1(d)) is composed of phosphor particles and silica gel which are mixed in certain proportion. The optical parameters of YAG phosphor film determines the light-emitting behavior (luminous efficiency, color temperature, etc.) of the final CSP WLED. After YAG phosphor is coated by SiO₂ layer (as shown in Fig.1(b), the optical constants of YAG@SiO₂ change accordingly, which can be calculated via Mie theory.



Fig. 1 Schematic diagram of (a) YAG phosphor particle (YAG); (b) YAG phosphor coated with SiO₂ (YAG@SiO₂); (c) YAG@SiO₂ cross sectional view; (d) YAG film (e) CSP WLED
We assume that spherical YAG and YAG@SiO₂ (YAG phosphor coated with a 10~40 nm SiO₂ layer) phosphor are evenly distributed in this film (as showed in Fig.1 (a) and (b)), where the yellow

region is YAG phosphor and the white one is SiO₂ layer (as shown in Fig.1(b)). The sectional view of YAG@SiO₂ is shown in Fig. 1(c), in which signal 1,2,3 represent the fluorescent material (YAG), coating layer material (SiO₂) and silicone respectively, a and b represent the radius of YAG and YAG@SiO₂ phosphor, respectively.

To be convenient, we assume that, first of all, the nano-SiO₂ layer coated on the surface of YAG phosphor is optically transparent in the visible light range. Secondly, YAG and YAG@SiO₂ phosphor are ideal smooth spheres, meanwhile, SiO₂ layer are tightly contacted with YAG phosphor in YAG@SiO₂. The schematic diagram of phosphor film is shown in Fig. 1 (d). The phosphor film is consisted of phosphor particles and silicone, while the YAG phosphor particle size is set as 2 μ m in this paper.

3. Calculation of optical constants via Mie theory

Before starting the optical simulation of WLED, the optical constants of YAG@SiO₂ phosphor need to be calculated via Mie theory [16]. Following is the process of the optical constants calculation. YAG phosphor can emit yellow light while being excited by blue light, thereby, 460 nm and 550 nm incident light as the light resource are chosen in the calculation. Algorithm process of optical parameters calculation is shown in Fig. 2.



Fig. 2 Algorithm process of optical parameters calculation

Based on the size of YAG and YAG@SiO₂ phosphor (a, b), the refractive index of YAG(n_{YAG}), SiO₂(n_{SiO_2}) and silicone(n_{sil}), the incident light wavelength in the ambient medium(λ), the scattering efficiency (Q_{sca}), absorption efficiency (Q_{abs}) and asymmetry parameters (asy) of YAG or YAG@SiO₂ phosphor can be calculated via Mie theory. Furthermore, the absorption coefficient (μ_{abs}), scattering coefficient(μ_{sca}) and asymmetry parameters (asy) of YAG and YAG@SiO₂ phosphor can also be calculated by Mie theory. The specific calculation process is illustrated below.

According to Mie scattering theory, x, y are the size constants, which can be calculated by equations (1) and (2):

$$x = k \times a \tag{1}$$

$$y = k \times b \tag{2}$$

As shown in Fig. 1(c), *a* is the radius of YAG phosphor and *b* is the overall radius of YAG@SiO₂. In addition, *b*-*a* is the coating thickness, *k* is the wave number in the ambient medium (silicone gel) which can be described by equation (3):

$$k = \frac{2\pi n_{sil}}{\lambda} \tag{3}$$

where λ is the incident light wavelength in the ambient medium. n_{sil} is silicone gel's refractive index. m_1 is the refractive index of YAG phosphor relative to the ambient medium, m_2 is the refractive index of SiO₂ coating relative to the ambient medium. Silica gel is the ambient medium in LED packaging. Here the following equations (4) and (5) give the expression of m_1 and m_2 .

$$m_{\rm I} = \frac{n_{\rm YAG}}{n_{\rm sil}} \tag{4}$$

$$m_2 = \frac{n_{sio_2}}{n_{si}} \tag{5}$$

YAG phosphor and SiO₂ both have scattering and absorption properties, so their refractive indices have a complex form:

$$n_{YAG} = n'_{YAG} - n''_{YAG} \times i$$
(6)

$$n_{SiO_2} = n'_{SiO_2} - n''_{SiO_2} \times i$$
(7)

where n' and n'' are the real and imaginary refractive indices of the phosphor particle, respectively. Tab. 1 shows the refractive indices of YAG and SiO₂ which are used in calculation.

Component	n	n
SiO ₂ coating [17]	460 nm, $n'_{SiO_2} = 1.484$	$n''_{SiO_2} = 4.00\text{E-07}$
	550 nm, $n'_{SiO_2} = 1.479$	$n'_{SiO_2} = 4.00\text{E-07}$
YAG [18]	460 nm, $n'_{YAG} = 1.851$	$n'_{YAG} = 5.12\text{E-}04$
	550 nm, $n'_{YAG} = 1.839$	$n'_{YAG} = 1.31\text{E-}05$

Table 1 Refractive indices of YAG and SiO₂

Here the following equations (8) to (11) give the expression for A_n , B_n , D_n and m, where ψ_n

and χ_n are Bessel functions, *m* is the refractive index with respect to the ambient medium, D_n is the logarithmic derivative of ψ_n .

$$A_{n} = \psi_{n}(m_{2}x) \frac{mD_{n}(m_{1}x) - D_{n}(m_{2}x)}{mD_{n}(m_{1}x)\chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(8)

$$B_{n} = \psi_{n}(m_{2}x) \frac{D_{n}(m_{1}x) / m - D_{n}(m_{2}x)}{D_{n}(m_{1}x) \chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(9)

$$m = \frac{m_2}{m_1} \tag{10}$$

$$D_n = \frac{\psi_n(mx)}{\psi_n(mx)} \tag{11}$$

Here the following equations (12) and (13) give the expression for D_n and G_n .

$$\tilde{D}_{n} = \frac{D_{n}(m_{2}y) - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$
(12)

$$\tilde{G}_{n} = \frac{D_{n}(m_{2}y) - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$
(13)

In Mie scattering theory, a_n and b_n are the Mie expansion scattering coefficients. They could be expressed by equations (14) and (15):

$$a_{n} = \frac{(\tilde{D}_{n}/m_{2} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(\tilde{D}_{n}/m_{2} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(14)

$$b_{n} = \frac{(m_{2}\tilde{G}_{n} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(m_{2}\tilde{G}_{n} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(15)

where ξ_n is Hankel functions of second kind.

According to Mie scattering theory, the extinction efficiency Q_{ext} , the scattering efficiency Q_{sca} , the absorption efficiency Q_{abs} , and the asymmetry parameter *asy* of optical medium are calculated according to equations (16) to (19) [19].

$$Q_{sca} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) \left(\left| a_n \right|^2 + \left| b_n \right|^2 \right)$$
(16)

$$Q_{ext} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) Re(a_n + b_n)$$
(17)

$$Q_{abs} = Q_{ext} - Q_{sca} \tag{18}$$

$$asy = \frac{4}{x^2} \left\{ \sum_{n=1}^{\infty} Re(a_n a_{(n+1)}^* + b_n b_{(n+1)}^*) \right\} / Q_{sca}$$
(19)

Among them, R_e represents the real part of the complex number, * represents the transpose.

Based on the results of Q_{sca} , and Q_{abs} , the absorption coefficient (μ_{abs}) and scattering coefficient (μ_{sca}) of YAG and YAG@SiO₂ are calculated according to equations (20) and (21)[20].

$$\mu_{abs} = Q_{abs} A v_f \cdot (1/V) = 3Q_{abs} v_f / 4b$$
⁽²⁰⁾

$$\mu_{sca} = Q_{sca} A v_f \cdot (1/V) = 3Q_{sca} v_f / 4b$$
(21)

where *A* is the geometrical cross area of the phosphor particle, *V* is the volume of the particle , v_f is the volume fraction of YAG or YAG@SiO₂. For YAG@SiO₂, v_f is described by equation (22):

$$v_{f} = \frac{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}}}{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}} + m_{_{sil}} / \rho_{_{sil}}}$$
(22)

 $m_{_{YAG}}$ is the mass of YAG phosphor, $m_{_{SIO_2}}$ is the mass of SiO₂, $m_{_{Sil}}$ is the mass of silica gel, $\rho_{_{YAG}}$ is the density of YAG phosphor, $\rho_{_{SIO_2}}$ is the density of SiO₂ and $\rho_{_{sil}}$ is the density of silica gel. In this calculation, $\rho_{_{YAG}}$, $\rho_{_{SIO_2}}$ and $\rho_{_{sil}}$ are set as 4.6, 2.2 and 1.1 g/cm³, respectively. In practical applications, mass fraction of YAG phosphor (w_f) in phosphor film is more commonly used instead of the volume fraction of phosphor (v_f), it is expressed as following:

$$w_f = \frac{m_{_{YAG}} + m_{_{SiO_2}}}{m_{_{YAG}} + m_{_{SiO_2}} + m_{_{Sil}}}$$
(23)

The absorption coefficient (μ_{abs}), scattering coefficient (μ_{sca}) and asymmetry parameter (*asy*) of the phosphor film affect the light absorption and scattering, therefore, show great influence on the light extraction and the final luminous efficiency of WLED. Concentration of YAG phosphors and a, b values are the main factors that affect the optical constants μ_{abs} , μ_{sca} and *asy* of the final fluorescent film. The influence of coating thickness (b-a), mass fraction of the phosphor (*w_f*) and incident light wavelength (λ) on μ_{abs} , μ_{sca} and *asy* of phosphor film are discussed through Mie scattering theory calculation. Generally, 460nm blue light excites YAG phosphor and generates yellow light with a dominant wavelength of 550nm. For simplicity , 460 μ_{abs} and 550 μ_{abs} denote the absorption coefficient of phosphors excited by 460nm and 560nm incident light, respectively.



Fig. 3 μ_{abs} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light

As shown in Fig.3 (a), $460\mu_{abs}$ increased as the thickness of SiO₂ layer increased from 0 to 20 nm, and then decreased when continue increasing the thickness to 40 nm. It is obviously noticed that $460\mu_{abs}$ reached the highest value when the phosphor coating is 20nm. Compared with pristine phosphor , after being coated with nano-SiO₂ layer, the photons mainly transmit the SiO₂ layer via increasing the absorption of blue light due to the low refractive index of SiO₂ and then get to the phosphor surface , therefore, the effective excitation absorption of the phosphor via the SiO₂ layer occurred [9]. Based on Lambert-Beer's law, the transmitted light through a layer of coating is inversely proportional to the thickness of coating material. Although the coating layer can decrease the reflectance (which enhances the luminescence properties), while the quantity of light escaping from phosphor is reduced in much thicker layer [13]. Therefore, in our research, when the coating thickness is 20nm, the absorption of 460nm blue light by YAG@ SiO₂ find the maximum value. Our calculation is entirely consistent with previous reports [13,21].

The incident light absorption coefficient $460\mu_{abs}$ and $550\mu_{abs}$ are not in the same order of magnitude as shown in Fig.3. $550\mu_{abs}$ is much smaller than $460\mu_{abs}$. Meanwhile, as shown in Fig.3 (b), for 550nm incident light, the thickness of the SiO₂ coating layers had little influence on the absorption coefficient of YAG phosphor film. All these are due to the fact that YAG phosphor crystals show quite different absorption coefficients while excited by blue or yellow light [22, 23], for blue light the absorption coefficient is 3-8mm⁻¹, however it is only 0.1-0.5mm⁻¹ for yellow light. Our calculation is in accordance with the experimental results.

While considering about the influence of mass fraction of the phosphor (w_f) on $460\mu_{abs}$ or $550\mu_{abs}$, as w_f increased from 0.1 to 0.7, there are more phosphor particles in the fluorescent film, the absorption of incident light increased, thus, $460\mu_{abs}$ or $550\mu_{abs}$ increased accordingly.



Fig.4 μ_{sca} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light As shown in Fig. 4, when the thickness of the SiO₂ coating layer increased, 460 μ_{sca} and 550 μ_{sca} of YAG@SiO₂ both slightly decreased, illustrated that less light energy is lost by scattering and more energy can be used for illumination by coating thicker SiO₂ layer. It is noting that using phosphors with smaller scattering coefficient could be a way to suppress the scattering loss. The results indicated that coating of SiO₂ suppressed the scattering loss in a certain extent [19]. While increase w_f of phosphor from 0.1 to 0.7, more light was scattered because there is more phosphor in the fluorescent film. Comparing the results in Fig.4 (a) and (b), it is found that the variation of μ_{sca} is very small when the incident light changes from blue light to yellow light. This indicates that the scattering property of coated phosphors are similar with uncoated one for different light, the big difference of absorption property between coated phosphor and uncoated one might be the main reason that affect the light extraction and luminous efficiency of WLED.



Fig.5 Asymmetry parameter asy of phosphor film

As shown in Fig.5, while excited by 460 nm or 550 nm incident light, *asy* of YAG and YAG@SiO₂ phosphor were positive, which meant under this condition, the number of forward scattered lights were greater than the number of backscattered lights [20]. While the coating thickness increased to 20nm, *asy* (460 nm or 550 nm excitation) increased a little, indicated the increasing of forward scattering. When coating thickness exceeded 20 nm, *asy* of YAG@SiO₂ had opposite trends while excited by 460 nm blue light or 550 nm yellow light. The increase of *asy*₄₆₀ indicated that the scattered light concentrated in smaller forward scattering angle, which resulted in an increase in the number of forward scattered light. Reversely, the decrease of *asy*₅₅₀ meant that more light was backscattered, absorbed and converted into heat loss. Herein, the backscattering loss of the emission from phosphor particles decreased the external quantum efficiency of the white LED [24]. If there are more forward scattered light existed in the packaged WLED, the luminous efficiency is improved as a result. The results in Fig.5 shows that the value of *asy*₅₅₀ and *asy*₄₆₀ is very close. When coating thickness changes, there is no great variation in *asy*. However, based on the previous results, it is clear that scattering property of phosphors is not the main reason for light

extraction in packaged WLED. The tiny difference between *asy550* and *asy460* almost have no effect on light extraction in packaged WLED.

4. Optical simulation of CSP WLED

In most commercial optical software such as Light Tools and Trace Pro, the phosphor scattering is normally treated as Mie scattering to bring about the optical simulation of white LED packaging. The precise optical constants calculation via Mie theory could afford necessary supports for the optical simulation in LED packaging design.

Depend on these obtained optical constants μ_{abs} , μ_{sca} and *asy*, we carried out the photoluminescence property simulation for YAG and YAG@SiO₂ WLED by Monte Carlo ray tracing method. The configuration of CSP WLED is given in Fig.6. The phosphor film is coated on the surface of the flip chip LED. The CSP chip is a 1 W blue LED chip or yellow LED chip (SAMSUNG LM101B) with dimension of 1mm×1mm×H mm, while H denotes the phosphor film thickness. The receiving surface (Receiver F) is assumed as a perfect absorber which collects blue light emitted from the blue LED chip and yellow light emitted from YAG or YAG@SiO₂ phosphor. To simplify the simulation, the radius of YAG particles is fixed at 2µm, coating thickness of YAG@SiO₂ is set at 20nm, mass fraction of the phosphor (*w_t*) in phosphor film is set at 0.7.



Fig.6 Configuration of Chip-Scale-Packaged (CSP) WLED

Generally, the most important thing in WLED packaging is the absorption and scattering properties of YAG phosphor for blue light emit from the chip and the yellow light emit from YAG phosphor itself. When the phosphor is excited by 460 nm blue light, the transmitted light is divided into two parts, unchanged blue light and converted yellow light. For 550 nm yellow light excitation, since no converted light is emitted from the phosphor film, the transmitted light is sorted as the yellow light. In this simulation, two 1W color LEDs with peak wavelength of 460 and 550nm are used as the light sources, coating thickness of YAG@SiO₂ is fixed at 20nm and the thickness of the phosphor film changes from 0.05 to 0.30 mm. The influence of the phosphor film thickness on light emission of CSP WLED was investigated and the results are shown in Fig.7. For the sake of simplicity, the transmittance for the unconverted blue light emit from blue LED and converted yellow light emit from phosphor are denoted as η_{460BT} and η_{460YT} . The transmittance of yellow light emit from phosphor are denoted as η_{550YT} . The total yellow light emits from phosphor excited by yellow LED are denoted as η_{550YT} . The subscript of these signals, such as 460 and 550 indicate the excitation wavelength.



Fig. 7 Simulation results of (a) Total yellow light emission from phosphor, the transmittance of YAG and YAG@SiO₂ phosphors for (b) yellow light emit from yellow LED (c) converted light emit from phosphor excited by blue light and (d) blue light emit from blue LED

As shown in Fig. 7 (a), when the phosphor is excited by 550nm yellow light, the total amount of yellow light scattered from YAG@SiO₂ phosphor is almost consistent with it from YAG phosphor. It is because SiO₂ almost has no absorption in the visible light range, hence, the absorption of yellow light by SiO₂ is negligible as shown in Fig. 7 (a). As seen from Table 1, the absorption coefficients of SiO₂ at 460nm and 550nm are basically the same, therefore, the absorption of 460nm blue light by the coated 20nm SiO₂ layer is also negligible.

As seen from the results of Fig.5, 550*asy* increase slightly while YAG phosphor was coated by 20nm SiO₂, indicates that under yellow light illumination, more of the light is forward scattered compared with pristine YAG phosphor. Therefore, as seen from Fig.7(b), η_{550YT} of YAG@SiO₂ is slightly higher than that of YAG phosphor. Based on Lambert-Beer's law, more light is absorbed when the thickness of the phosphor film H increased from 0.05 to 0.3mm, therefore, η_{550YT} of YAG and YAG@SiO₂ decreased as a result.

Fig. 7(c) and (d) show us the transmittance for the converted yellow light (η_{460YT}) and the unconverted blue light (η_{460BT}) excited by blue LED. It shows that η_{460YT} increase but η_{460BT} decrease while the phosphor film thickness increase. This is in accordance with the result of Lambert-Beer's law , while more blue light could be absorbed by phosphors as the phosphor film is thicker, therefore, less unconverted blue light but more converted yellow light emit out. When the phosphor film thickness is the same, η_{460YT} of YAG@SiO₂ is greater than that of YAG. This is due to the fact that YAG@SiO₂ possess higher $460\mu_{abs}$ (see Fig.4(a)), hence more blue light is absorbed by YAG@SiO₂ compared with YAG, accordingly more light is converted into yellow light emission, as many earlier scholars reported. [13,21]



Fig. 8 Conversion efficiency of phosphor

Fig. 8 shows the conversion efficiency of YAG and YAG@SiO₂ excited by blue LED. As the thickness of the phosphor film increases, the conversion efficiency of phosphor gradually decreases, it might due to the fact that when the film is too thick or the phosphor concentration is too high, the oversaturated phosphor causes more converted light to be back reflected [19], and less light to be forward reflected. This might cause multiple reflection of the converted light between the phosphor layer and the chip. The multiple reflection result in the high absorption of converted light and decrease of luminous efficiency. However, YAG@SiO₂ has a 1.2% higher conversion efficiency than YAG, which implies that phosphor coating might be an effective way to improve the light efficiency.

In order to generate white light, the luminescence efficiency and true color map of the CSP WLED with different YAG film thickness (H) is simulated. As the thickness of the YAG fluorescent film increases, the luminous efficacy and color temperature of blue LED excited WLED gradually increase. When H is 0.3mm, the luminous efficiency gradually reaches saturation. When H is 0.2mm, the fabricated CSP LED possess a cold white light emission with a CCT of 10066K, color

coordinates of (0.2851, 0.2786) (as shown in Fig.11(b)) and a luminous efficacy up to 130.3 lm/W (as shown in Fig.9).



Fig. 9 Influence of YAG fluorescent film thickness on luminous efficiency of YAG WLED

The fluorescent film thickness (H) is fixed at 0.2mm, the influence of SiO₂ coating thickness on the luminous efficiency (LEE) and Correlate Color Temperature (CCT) of CSP WLED are shown in Fig.10. With the increasing of SiO₂ coating thickness, LEE of CSP WLED firstly increase and then decrease. When the coating thickness is 20nm, the luminous efficacy reached the maximum value 138.92 lm/W. This might due to the fact that $460\mu_{abs}$ of YAG@SiO₂ phosphor reaches the highest value while the SiO₂ coating thickness is 20 nm. Under this condition, more blue light emitted from the chip could be absorbed by YAG@SiO₂ phosphor film. More absorption of blue light by the YAG@SiO₂ phosphor, more emission of yellow light, therefore enhanced LEE is obtained.



Fig.10 Influence of coating thickness on LEE and CCT of CSP WLED

Meanwhile, CCT of YAG@SiO₂ WLED decreases when the thickness of SiO₂ coating layer increases from 0 to 20 nm. When the thickness of the SiO₂ coating layer is over 20 nm, the color temperature of YAG@SiO₂ WLED increases sharply. Low color temperature WLED is prefer under working condition. It is found that proper SiO₂ layer thickness endowing YAG@SiO₂ with more absorption of blue light and high output of yellow light, therefore significantly enhance the LEE and decrease the CCT of WLED. The highest value of LEE, 138.92 lm/W, the lowest CCT, 6667K, are achieved at a SiO₂ layer thickness of 20nm. The simulation results above show that proper SiO₂ coating on phosphors is responsible for the enhanced luminous efficacy and lower color temperature of CSP WLED, which is in accordance with the former reports. [21]

Using Monte Carlo method, the quality of white light emission from the YAG and YAG@SiO₂ WLED was evaluated via CIE chromaticity diagram and Luminous flux figure (as shown in Fig.11). The results are listed in Table 2.



Fig. 11 (a) Luminous flux figure of YAG WLED; (b)Luminous flux figure of YAG@SiO₂WLED; (c) Chromaticity color coordinates of YAG and YAG@SiO₂ upon excitation at 460 nm

Kay fracing method						
Phosphor	LEE (lm/W)	CCT (K)	CIE (x, y)	Fluorescence conversion efficiency		
YAG	132.11	10066	(0.2851,0.2786)	0.4299		
YAG@SiO ₂	138.92	6637	(0.3110,0.3244)	0.4392		

Table. 2 Optical properties of YAG and YAG@SiO₂ WLEDs Simulated by Monta Carlo Ray Tracing method

When the thickness of fluorescent film is 0.2 mm, SiO₂ coating layer is 20 nm, YAG@SiO₂ WLED shows a light efficiency of 138.92 lm/W, a color temperature of 6637K, and a color coordinate of (0.3110, 0.3244), as shown in Tab.2. Compared with original YAG WLED, higher LEE and lower CCT is achieved in YAG@SiO₂ WLED, which is resulted from enhanced forward scattering and stronger blue light absorption. Meanwhile, the color coordinates of YAG@SiO₂ WLED is closer to the theoretical white point of (0.33, 0.33). This result shows that an ideal white color is almost achieved in YAG@SiO₂ under 460nm blue LED excitation. Meanwhile, proper SiO₂ thin layer coating on YAG significantly enhanced LEE and CCT of WLED, and a good cold white light emission is achieved.

Our simulation gives a theoretical explanation about the reason why proper coating thickness on YAG phosphor endows the CSP WLED with higher luminous efficacy and lower color temperature, hence better luminescence properties.

5. Conclusions

Optical configuration of chip scale packages WLEDs are established by coating YAG or YAG@SiO₂ phosphor film directly on the chip surface. In order to ensure the correct simulation of luminescence properties of the CSP white LED, the specific optical constants including the absorption coefficient μ_{abs} , scattering coefficient μ_{sca} , and anisotropy factor asy of YAG and YAG@SiO₂ are calculated based on Mie scattering theory. The dependency of coating thickness of SiO₂ layer and phosphor mass fraction w_f on optical constants μ_{abs} , μ_{sca} and asy are investigated. It shows that when the coating thickness is 20 nm, the absorption coefficient increases the most, which is conducive to increase the absorption of blue light, enhance the yellow light emission and eventually improve the luminescence property. The decrease in scattering coefficient is also conducive to the improvement of luminous efficiency. Numerical results show that Mie theory is effective in predicting the changing tendencies of the optical constants as the mass fraction of phosphor or the coating thickness changes. It makes Mie theory a suitable tool in WLED packaging design. Two color LEDs are used as light sources to simulate the light extraction of YAG and YAG@SiO₂ WLED via Monte Carlo ray tracing method. It implies that SiO₂ coating mainly result in the enhanced absorption of blue light and yellow light converting, hence the higher conversion efficiency for YAG@SiO₂. As the thickness of the fluorescent film is 0.2 mm, with 2 μ m YAG@SiO₂ coated by 20 nm SiO₂ layer in it, our WLED gives a light efficiency of 138 lm/W, a color temperature of 6637 K, and a color coordinate of (0.3110, 0.3244), The light conversion efficiency after coating is increased by 1.2% compared with that before coating.

The simulation of photoluminescence property of YAG@SiO₂ WLED can be adapted to various coated phosphors WLED systems, the color quality can be easily tuned by changing the coating thickness, the phosphor film thickness or the mass fraction of phosphor, which have potential use in the future WLED packaging designing.

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References

- H.T. Zhu, X.H. Liu, R.L. Fu, Y.H. Shi, H. Wang, Q.J. He, X.F. Song, Luminous efficiency enhancement of WLEDs via patterned RGB phosphor arrays, J. Lumin. 211 (2019) 1-7.
- [2] Q. He, R. Fu, X. Song, H. Zhu, X. Su, C. You, Tunable luminescence and energy transfer from Ce3+ to Dy3+ in Ca3Al2O6 host matrix prepared via a facile sol-gel process, J. Alloy. Compd. 810 (2019) 151960.
- [3] B. Sun, X. Jiang, K.-C. Yung, J. Fan, M.G. Pecht, A Review of Prognostic Techniques for High-Power White LEDs, IEEE Transactions on Power Electronics 32 (2017) 6338-6362.
- [4] M.-H. Chang, D. Das, P.V. Varde, M. Pecht, Light emitting diodes reliability review, Microelectronics Reliability 52 (2012) 762-782.
- [5] J. Fan, C. Yu, C. Qian, X. Fan, G. Zhang, Thermal/luminescence characterization and degradation mechanism analysis on phosphor-converted white LED chip scale packages, Microelectronics Reliability 74 (2017) 179-

185.

- [6] J. Bhardwaj, J.M. Cesaratto, I.H. Wildeson, H. Choy, A. Tandon, W.A. Soer, P.J. Schmidt, B. Spinger, P. Deb,
 O.B. Shchekin, W. Götz, Progress in high-luminance LED technology for solid-state lighting, physica status solidi (a) 214 (2017) 1600826.
- [7] J. Zhong, D. Chen, Y. Zhou, Z. Wan, M. Ding, Z. Ji, Stable and chromaticity-tunable phosphor-in-glass inorganic color converter for high-power warm white light-emitting diode, J. Eur. Ceram. Soc. 36 (2016) 1705-1713.
- [8] H.S. Lee, J.W. Yoo, Yellow phosphors coated with TiO2 for the enhancement of photoluminescence and thermal stability, Appl. Surf. Sci. 257 (2011) 8355-8359.
- [9] Meiqi Chang, Yanhua Song, Ye Sheng, Jie Chen, H. Zou, Understanding the remarkable luminescence enhancement via SiO2 coating on TiO2:Eu3+ nanofibers, PCCP 19 (2017) 17063-17074.
- [10] S. Li, Q. Zhu, D. Tang, X. Liu, G. Ouyang, L. Cao, N. Hirosaki, T. Nishimura, Z. Huang, R.-J. Xie, Al2O3– YAG:Ce composite phosphor ceramic: a thermally robust and efficient color converter for solid state laser lighting, J. Mater. Chem. C 4 (2016) 8648-8654.
- [11] G. Feng, W. Jiang, J. Liu, C. Li, Q. Zhang, L. Miao, Q. Wu, Synthesis and luminescence properties of Al2O3@YAG: Ce core–shell yellow phosphor for white LED application, Ceram. Int. 44 (2018) 8435-8439.
- [12] G. Li, M. Lv, J. Dai, X. Li, Comparative study on two synthesis methods of core-shell structured SiO2@Y2O3:Eu3+ particles and their luminescence properties, Opt. Mater. 46 (2015) 40-44.
- [13] Xiong M, Xi X, Gong H, et al. Effects of SiO2 coating on luminescence property and thermostability of Sr2MgSi2O7: Eu2+, Dy3+phosphors[J]. Journal of Sol-Gel Science and Technology, 81 (2017) 894-902.
- [14] Secu M, Cernea M, Secu C E, et al. Structural and optical properties of fluorescent BaFBrEu2+@SiO2 core/shell phosphor heterostructure[J]. Materials Chemistry and Physics, 2015, 151:81-86.

[15] Han J K , Hirata G A , Talbot J B , Luminescence enhancement of Y_2O_3 :Eu³⁺ and Y_2SiO_5 :Ce³⁺,Tb³⁺ core particles with SiO2 shells, Materials Science & Engineering B,5 (2011) 436-441.

[16] Mtzler C . MATLAB functions for Mie scattering and absorption. 2002.

- [17] Kraisinger C J , Xu W Q , Snyder M J . Optical properties of undoped and neodymium doped polycrystalline yttrium aluminum garnet[C] Window and Dome Technologies and Materials XVI. 2019.
- [18] Pfeiffer K , Shestaeva S , Bingel A , et al. Comparative study of ALD SiO₂ thin films for optical applications[J]. Optical Materials Express, 2016, 6(2):660.
- [19] Liu Z, Liu S, Wang K, et al. Measurement and Numerical Studies of Optical Properties of YAG:Ce Phosphor for White Light-Emitting Diode Packaging[J]. Applied Optics, 2010, 49(2):247-257.
- [20] Hu R, Fu X , Zou Y , et al. A complementary study to "Toward scatter-free phosphors in white phosphorconverted light-emitting diodes:" comment[J]. Optics Express, 2013, 21(4):5071-3.
- [21] S.M. Rafiaei, S. Kang, Effect of nano-sized SiO2 on the optical properties of YVO4:Eu3+ phosphors, Compos. Interfaces 24 (2016) 319-333.
- [22] S.M.Kacznarek, G Domianiak-Dzik, W. Ryba-Romanowski et al. Changes in optical properties of Ce:YAG crystals under annealing and irradiation processing. Crystal Research and Technology, 1999, 34: 1031-1036.
- [23] E. Mihokova, M. Nikl, A. Mares et al. Luminescence and scintillation properties of YAG: Ce single crystal and optical ceramics. Journal of Luminescence, 2007, 126: 77-80.
- [24] R. Kasuya, A. Kawano, T. Isobe, H. Kuma, and J. Katano, Characteristic optical properties of transparent color conversion film prepared from YAG: Ce³⁺ nanoparticles, Appl. Phys. Lett, 2007, 91: 111916

Simulation of Optical behavior of YAG:Ce³⁺@SiO₂ phosphor used for chip scale packages WLED

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Abstract

YAG:Ce³⁺ yellow phosphor are particularly used luminescent materials to produce white light in phosphor-converted white LED (pc-WLED). Surface coating of YAG phosphor is the main concern for desired optical performance of the phosphors. Many scholars conducted various experimental analysis on the surface coating of phosphors to improve yellow emission, but the theoretical explanation by which phosphor coating could help improving light efficiency has not yet been studied. In this paper, based on Mie theory, the optical constants such as scattering coefficient, absorption coefficient and asymmetry parameter of YAG:Ce³⁺ phosphor and YAG@SiO₂ (YAG:Ce³⁺ phosphor surface coated with nano-SiO₂ layer) were calculated. An optical configuration of chip scale packages (CSP) WLED was constructed by coupling YAG:Ce³⁺ or YAG@SiO₂ phosphors with a LED laser. Based on the optical parameters calculated by Mie theory, the luminescent properties of YAG:Ce³⁺ and YAG@SiO₂ WLED were simulated by Monte Carlo method. The results showed that a thin SiO₂ coating layer on YAG phosphor result in an overall increase in luminous performances compared with original YAG WLED. The absorption coefficient of phosphor is the main concern affecting the light emission in WLED. Due to the fact that YAG@SiO₂ possess higher $460\mu_{abs}$, it could absorb more blue light than YAG, thereby it has a 1.2% higher conversion efficiency than YAG, finally the enhanced luminous efficiency of YAG@SiO₂ WLED is obtained. The results obtained in this work provides a potential method in future WLED packaging designing.

1. Introduction

White lighting-emitting-diode (WLED) has been widely used in commercial solid lighting applications because of its small size, long life, energy saving, environmentally friendly and high luminous efficiency properties [1, 2]. The most appropriate method to obtain WLED is called phosphor-converted (pc-) WLED. Typically, a pc-WLED is usually fabricated by combining the blue LED chip with YAG:Ce³⁺ phosphors which has acceptable color rendering and robust reliability. Traditionally, a pc-WLED package consists of LED chip, phosphors, lead frame, silicone, substrate and so on [3]. However, more packaging components in WLED package indicate higher failure possibility as well as more space occupation and more weight^[4]. The chip scale package (CSP) technology is developed by covering a thin YAG fluorescent film on a blue LED chip, which could tackle this problem. The advantages of CSP WLED are the increased manufacturing efficiency [5, 6], high packing density and high luminous flux output. In the package, refractive index of silica gel (1.41) is lower than that of YAG: Ce^{3+} crystal (1.84) in the thin phosphor film, therefore, more yellow light is absorbed by phosphor particle due to the total internal reflection (TIR), luminous efficiency of the CSP WLED decreases accordingly. At the same time, the refractive index difference between phosphor and silica gel leads to light scattering at the interface, which also results in the blue light reflection loss and the decrease of luminous efficiency [7]. More recently, some studies try to solve the problem by coating a dielectric layer with suitable refractive index on the phosphor. This refers to coating one or more

layers of oxide material on the surface of the phosphor particles, such as TiO₂ [8, 9], Al₂O₃ [10, 11] and SiO₂ [12, 13]. The oxide material coating on the phosphors with matched refractive index could reduce the yellow light absorption by TIR, decrease the blue light reflection loss at the interface, in the end, improve the luminous efficiency of WLED. Among them, SiO₂ is widely used due to its optical transparency, tunable size [14] and low cost [15]. It has been have concluded that SiO₂-coated YAG phosphor limits the thermal quenching properties [16, 17]. Therefore, YAG phosphor coated with SiO₂ layer(YAG@SiO₂) could be considered as a good candidate for white light-emitting diode applications^[18]. Many scholars conducted experimental analysis on phosphor coating, most of the studies focus on the influence of oxide layer microstructure on the luminous efficiency of WLED evaluated by photoluminescence spectra (PL spectra), but no one go deep into the light efficiency enhancement mechanism investigations. Few researchers seriously considered how the variation of light absorption and scattering of oxide layer coated phosphor affect the light extraction of WLED. Meanwhile, the optical parameters such as scattering coefficient (μ_{sca}), absorption coefficient (μ_{abs}) and anisotropy parameter (μ_{abs}) of the coated phosphors also change as well. Actually, precise optical constants of coated phosphor are indispensable in the numerical simulation of the luminescent property of WLED. However, few research discussed about this, to the best of our knowledge.

In this paper, the YAG:Ce³⁺ and YAG@SiO₂ were chosen as the optical simulation target. Firstly, consider the YAG and YAG@SiO₂ phosphor as spheres, the optical constants of these two phosphors were calculated based on Mie theory. Secondly, based on the optical constants of YAG and YAG@SiO₂ phosphor obtained, the luminescence performances of YAG and YAG@SiO₂ CSP WLED were simulated based on Monte Carlo method. Thirdly, in view of the foregoing results, we hold the opinion that this method can be extended to other coating layers and phosphor systems and it is helpful to
decrease the amount of experiments significantly.

2. Description of the configuration of CSP-packaged WLED

The configuration of CSP-packaged WLED is constructed as shown in Fig. 1. In CSP LEDs, blue LED chips are mostly covered with yellow YAG fluorescent film to generate white emission (as shown in Fig.1 (e)). The YAG fluorescent film (as shown in Fig. 1(d)) is composed of phosphor particles and silica gel which are mixed in certain proportion. The optical parameters of YAG phosphor film determines the light-emitting behavior (luminous efficiency, color temperature, etc.) of the final CSP WLED. After YAG phosphor is coated by SiO₂ layer (as shown in Fig.1(b), the optical constants of YAG@SiO₂ change accordingly, which can be calculated via Mie theory.



Fig. 1 Schematic diagram of (a) YAG phosphor particle (YAG); (b) YAG phosphor coated with SiO₂ (YAG@SiO₂); (c) YAG@SiO₂ cross sectional view; (d) YAG film (e) CSP WLED

We assume that spherical YAG and YAG@SiO₂ (YAG phosphor coated with a 10~40 nm SiO₂ layer) phosphor are evenly distributed in this film (as showed in Fig.1 (a) and (b)), where the yellow region is YAG phosphor and the white one is SiO₂ layer (as shown in Fig.1(b)). The sectional view of YAG@SiO₂ is shown in Fig. 1(c), in which signal 1,2,3 represent the fluorescent material (YAG),

coating layer material (SiO₂) and silicone respectively, a and b represent the radius of YAG and YAG@SiO₂ phosphor, respectively.

To be convenient, we assume that, first of all, the nano-SiO₂ layer coated on the surface of YAG phosphor is optically transparent in the visible light range. Secondly, YAG and YAG@SiO₂ phosphor are ideal smooth spheres, meanwhile, SiO₂ layer are tightly contacted with YAG phosphor in YAG@SiO₂. The schematic diagram of phosphor film is shown in Fig. 1 (d). The phosphor film is consisted of phosphor particles and silicone, while the YAG phosphor particle size is set as 2 μ m in this paper.

3. Calculation of optical constants via Mie theory

Before starting the optical simulation of WLED, the optical constants of YAG@SiO₂ phosphor need to be calculated via Mie theory [19]. Following is the process of the optical constants calculation. YAG phosphor can emit yellow light while being excited by blue light, thereby, 460 nm and 550 nm incident light as the light resource are chosen in the calculation. Algorithm process of optical parameters calculation is shown in Fig. 2.



Fig. 2 Algorithm process of optical parameters calculation

Based on the size of YAG and YAG@SiO₂ phosphor (a, b), the refractive index of YAG(n_{YAG}), SiO₂(n_{SiO_2}) and silicone(n_{sil}), the incident light wavelength in the ambient medium(λ), the scattering efficiency(Q_{sca}), absorption efficiency(Q_{abs}) and asymmetry parameters(asy) of YAG or YAG@SiO₂ phosphor can be calculated via Mie theory. Furthermore, the absorption coefficient (μ_{abs}), scattering coefficient(μ_{sca}) and asymmetry parameters (asy) of YAG and YAG@SiO₂ phosphor can also be calculated by Mie theory. The specific calculation process is illustrated below.

According to Mie scattering theory, x, y are the size constants, which can be calculated by equations (1) and (2):

$$x = k \times a \tag{1}$$

$$y = k \times b \tag{2}$$

As shown in Fig. 1(c), *a* is the radius of YAG phosphor and *b* is the overall radius of YAG@SiO₂. In addition, *b*-*a* is the coating thickness, *k* is the wave number in the ambient medium (silicone gel) which can be described by equation (3):

$$k = \frac{2\pi n_{sil}}{\lambda} \tag{3}$$

where λ is the incident light wavelength in the ambient medium. n_{sil} is silicone gel's refractive index. m_1 is the refractive index of YAG phosphor relative to the ambient medium, m_2 is the refractive index of SiO₂ coating relative to the ambient medium. Silica gel is the ambient medium in LED packaging. Here the following equations (4) and (5) give the expression of m_1 and m_2 .

$$m_{\rm I} = \frac{n_{\rm YAG}}{n_{\rm sil}} \tag{4}$$

$$m_2 = \frac{n_{sio_2}}{n_{sil}} \tag{5}$$

YAG phosphor and SiO₂ both have scattering and absorption properties, so their refractive indices have a complex form:

$$n_{YAG} = n_{YAG} - n_{YAG} \times i$$
(6)

$$n_{SiO_2} = n_{SiO_2} - n_{SiO_2} \times i$$
(7)

where n' and n'' are the refractive index and extinction coefficient. The relationship between n' and n'' is shown as following:

$$n'' = \alpha \lambda / 4\pi n' \tag{8}$$

where α is absorption coefficient, λ is the incident wavelength.

Table 1 lists the parameters of involved material. Most of the light can directly pass through the SiO₂ layer, the scattering effect is not obvious, and the scattering coefficient of SiO₂ is almost 0. As showed in Table 1, the transmittance(T) of SiO₂ is close to 1 which means SiO₂ have good optical transparency. Meantime, SiO₂ almost has no absorption in the visible light range. The absorption coefficient (α), refractive index(n) and extinction coefficient(n) were shown in table1 which can be used in calculation.

Table 1 parameters of YAG and SiO₂[20-22]

Components	parameters		
SiO ₂ layer	$\lambda = 460 \text{ nm}, \ n_{SiO_2} = 1.484, \ n_{SiO_2} = 4.00\text{E-07}$	$\alpha = 0.162 \text{ cm}^{-1}, \ T = 0.987$,	
	$\lambda = 550 \text{ nm}, \ n_{SiO_2} = 1.479, \ n_{SiO_2} = 4.00\text{E-}07$	$\alpha = 0.1352 \text{ cm}^{-1}, T = 0.991$	
YAG	$\lambda = 460 \text{ nm}, \ n'_{YAG} = 1.851, \ n''_{YAG} = 5.12\text{E-}04$	$\alpha = 258.897 \text{ cm}^{-1}$	
	$\lambda = 550 \text{ nm}, \ n'_{YAG} = 1.839, \ n''_{YAG} = 1.31\text{E-}05$	$\alpha = 5.984 \text{ cm}^{-1}$	

Here the following equations (9) to (12) give the expression for A_n , B_n , D_n and m, where ψ_n and χ_n are Bessel functions, m is the refractive index with respect to the ambient medium, D_n is the logarithmic derivative of ψ_n .

$$A_{n} = \psi_{n}(m_{2}x) \frac{mD_{n}(m_{1}x) - D_{n}(m_{2}x)}{mD_{n}(m_{1}x)\chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(9)

$$B_{n} = \psi_{n}(m_{2}x) \frac{D_{n}(m_{1}x) / m - D_{n}(m_{2}x)}{D_{n}(m_{1}x) \chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(10)

$$m = \frac{m_2}{m_1} \tag{11}$$

$$D_n = \frac{\psi_n(mx)}{\psi_n(mx)} \tag{12}$$

Here the following equations (13) and (14) give the expression for D_n and G_n .

$$\tilde{D}_{n} = \frac{D_{n}(m_{2}y) - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$

$$\tilde{G}_{n} = \frac{D_{n}(m_{2}y) - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$
(13)

In Mie scattering theory, a_n and b_n are the Mie expansion scattering coefficients. They could be expressed by equations (15) and (16):

$$a_{n} = \frac{(D_{n}/m_{2} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(\tilde{D}_{n}/m_{2} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(15)

$$b_{n} = \frac{(m_{2}\tilde{G}_{n} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(m_{2}\tilde{G}_{n} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(16)

where ξ_n is Hankel functions of second kind.

According to Mie scattering theory, the extinction efficiency Q_{ext} , the scattering efficiency Q_{sca} , the absorption efficiency Q_{abs} , and the asymmetry parameter *asy* of optical medium are calculated according to equations (17) to (20) [22].

$$Q_{sca} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) \left(\left| a_n \right|^2 + \left| b_n \right|^2 \right)$$
(17)

$$Q_{ext} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) Re(a_n + b_n)$$
(18)

$$Q_{abs} = Q_{ext} - Q_{sca} \tag{19}$$

$$asy = \frac{4}{x^2} \left\{ \sum_{n=1}^{\infty} Re(a_n a_{(n+1)}^* + b_n b_{(n+1)}^*) \right\} / Q_{sca}$$
(20)

Among them, R_e represents the real part of the complex number, * represents the transpose.

Based on the results of Q_{sca} , and Q_{abs} , the absorption coefficient (μ_{abs}) and scattering coefficient (μ_{sca}) of YAG and YAG@SiO₂ are calculated according to equations (21) and (22)[22].

$$\mu_{abs} = Q_{abs} A v_f \cdot (1/V) = 3Q_{abs} v_f / 4b$$
⁽²¹⁾

$$\mu_{sca} = Q_{sca} A v_f \cdot (1/V) = 3Q_{sca} v_f / 4b$$
(22)

where *A* is the geometrical cross area of the phosphor particle, *V* is the volume of the particle , v_f is the volume fraction of YAG or YAG@SiO₂. For YAG@SiO₂, v_f is described by equation (23):

$$v_{f} = \frac{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}}}{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}} + m_{_{sil}} / \rho_{_{sil}}}$$
(23)

 $m_{_{YAG}}$ is the mass of YAG phosphor, $m_{_{SIO_2}}$ is the mass of SiO₂, $m_{_{Sil}}$ is the mass of silica gel, $\rho_{_{YAG}}$ is the density of YAG phosphor, $\rho_{_{SIO_2}}$ is the density of SiO₂ and $\rho_{_{sil}}$ is the density of silica gel. In this calculation, $\rho_{_{YAG}}$, $\rho_{_{SIO_2}}$ and $\rho_{_{sil}}$ are set as 4.6, 2.2 and 1.1 g/cm³, respectively. In practical applications, mass fraction of YAG phosphor (w_f) in phosphor film is more commonly used instead of the volume fraction of phosphor (v_f), it is expressed as following:

$$w_f = \frac{m_{_{YAG}} + m_{_{SIO_2}}}{m_{_{YAG}} + m_{_{SIO_2}} + m_{_{SII}}}$$
(24)

The absorption coefficient (μ_{abs}), scattering coefficient (μ_{sca}) and asymmetry parameter (*asy*) of the phosphor film affect the light absorption and scattering, therefore, show great influence on the light extraction and the final luminous efficiency of WLED. Concentration of YAG phosphors and a, b values are the main factors that affect the optical constants μ_{abs} , μ_{sca} and *asy* of the final fluorescent film. The influence of coating thickness (b-a), mass fraction of the phosphor (*w_f*) and incident light wavelength (λ) on μ_{abs} , μ_{sca} and *asy* of phosphor film are discussed through Mie scattering theory calculation. Generally, 460nm blue light excites YAG phosphor and generates yellow light with a dominant wavelength of 550nm. For simplicity, 460 μ_{abs} and 550 μ_{abs} denote the absorption coefficient of phosphors excited by 460nm and 550nm incident light, respectively. 460 μ_{sca} and 550 μ_{sca} denote the scattering coefficient of phosphors excited by 460nm and 550nm incident light, respectively.



Fig. 3 μ_{abs} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light

As shown in Fig.3 (a), $460\mu_{abs}$ increased as the thickness of SiO₂ layer increased from 0 to 20 nm, and then decreased when continue increasing the thickness to 40 nm. It is obviously noticed that $460\mu_{abs}$ reached the highest value when the phosphor coating is 20nm. Compared with pristine phosphor , after being coated with nano-SiO₂ layer, the photons mainly transmit the SiO₂ layer via increasing the absorption of blue light due to the low refractive index of SiO₂ and then get to the phosphor surface , therefore, the effective excitation absorption of the phosphor via the SiO₂ layer occurred [9]. Based on Lambert-Beer's law, the transmitted light through a layer of coating is inversely proportional to the thickness of coating material. Although the coating layer can decrease the reflectance (which enhances the luminescence properties), while the quantity of light escaping from phosphor is reduced in much thicker layer [13]. Therefore, in our research, when the coating thickness is 20nm, the absorption of 460nm blue light by YAG@ SiO₂ find the maximum value. Our calculation is entirely consistent with previous reports [13,24].

The incident light absorption coefficient $460\mu_{abs}$ and $550\mu_{abs}$ are not in the same order of magnitude as shown in Fig.3. $550\mu_{abs}$ is much smaller than $460\mu_{abs}$. Meanwhile, as shown in Fig.3 (b), for 550nm incident light, the thickness of the SiO₂ coating layers had little influence on the

absorption coefficient of YAG phosphor film. All these are due to the fact that YAG phosphor crystals show quite different absorption coefficients while excited by blue or yellow light [25, 26], for blue light the absorption coefficient is 3-8 mm⁻¹, however it is only 0.1-0.5 mm⁻¹ for yellow light. Our calculation is in accordance with the experimental results.

While considering about the influence of mass fraction of the phosphor (w_f) on $460\mu_{abs}$ or $550\mu_{abs}$, as w_f increased from 0.1 to 0.7, there are more phosphor particles in the fluorescent film, the absorption of incident light increased, thus, $460\mu_{abs}$ or $550\mu_{abs}$ increased accordingly.



Fig.4 μ_{sca} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light

As shown in Fig. 4, when the thickness of the SiO₂ coating layer increased, $460\mu_{sca}$ and $550\mu_{sca}$ of YAG@SiO₂ both slightly decreased, illustrated that less light energy is lost by scattering and more energy can be used for illumination by coating thicker SiO₂ layer. It is noting that using phosphors with smaller scattering coefficient could be a way to suppress the scattering loss. The results indicated that coating of SiO₂ suppressed the scattering loss in a certain extent [22]. While increase w_f of phosphor from 0.1 to 0.7, more light was scattered because there is more phosphor in the fluorescent film. Comparing the results in Fig.4 (a) and (b), it is found that the variation of μ_{sca} is very small when the incident light changes from blue light to yellow light. This indicates that the scattering

property of coated phosphors are similar with uncoated one for different light, the big difference of absorption property between coated phosphor and uncoated one might be the main reason that affect the light extraction and luminous efficiency of WLED.





As shown in Fig.5, while excited by 460 nm or 550 nm incident light, *asy* of YAG and YAG@SiO₂ phosphor were positive, which meant under this condition, the number of forward scattered lights were greater than the number of backscattered lights [23]. While the coating thickness increased to 20nm, *asy* (460 nm or 550 nm excitation) increased a little, indicated the increasing of forward scattering. When coating thickness exceeded 20 nm, *asy* of YAG@SiO₂ had opposite trends while excited by 460 nm blue light or 550 nm yellow light. The increase of *asy*₄₆₀ indicated that the scattered light concentrated in smaller forward scattering angle, which resulted in an increase in the number of forward scattered light. Reversely, the decrease of *asy*₄₅₀ meant that more light was backscattered, absorbed and converted into heat loss. Herein, the backscattering loss of the emission from phosphor particles decreased the external quantum efficiency of the white LED [27]. If there are more forward scattered light existed in the packaged WLED, the luminous efficiency is improved as a result. The results in Fig.5 shows that the value of *asy*₄₅₀ and *asy*₄₆₀ is very close. When coating thickness changes,

there is no great variation in *asy*. However, based on the previous results, it is clear that scattering property of phosphors is not the main reason for light extraction in packaged WLED. The tiny difference between *asy*₅₅₀ and *asy*₄₆₀ almost have no effect on light extraction in packaged WLED.

4. Optical simulation of CSP-packaged WLED

In most commercial optical software such as Light Tools and Trace Pro, the phosphor scattering is normally treated as Mie scattering to bring about the optical simulation of white LED packaging. The precise optical constants calculation via Mie theory could afford necessary supports for the optical simulation in LED packaging design.

Depend on these obtained optical constants μ_{abs} , μ_{sca} and *asy*, we carried out the photoluminescence property simulation for YAG and YAG@SiO₂ WLED by Monte Carlo ray tracing method. The configuration of CSP-packaged WLED is given in Fig.6. The phosphor film is coated on the surface of the flip chip LED. The CSP chip is a 1 W blue LED chip or yellow LED chip (SAMSUNG LM101B) with dimension of 1mm×1mm×H mm, while H denotes the phosphor film thickness. The receiving surface (Receiver F) is assumed as a perfect absorber which collects blue light emitted from the blue LED chip and yellow light emitted from YAG or YAG@SiO₂ phosphor. To simplify the simulation, the radius of YAG particles is fixed at 2µm, coating thickness of YAG@SiO₂ is set at 20nm, mass fraction of the phosphor (*w*) in phosphor film is set at 0.7.



Fig.6 Configuration of Chip-Scale-Packaged (CSP) WLED

Generally, the most important thing in WLED packaging is the absorption and scattering properties of YAG phosphor for blue light emit from the chip and the yellow light emit from YAG phosphor itself. When the phosphor is excited by 460 nm blue light, the transmitted light is divided into two parts, unchanged blue light and converted yellow light. For 550 nm yellow light excitation, since no converted light is emitted from the phosphor film, the transmitted light is sorted as the yellow light. In this simulation, two 1W color LEDs with peak wavelength of 460 and 550nm are used as the light sources, coating thickness of YAG@SiO₂ is fixed at 20nm and the thickness of the phosphor film changes from 0.05 to 0.30 mm. The influence of the phosphor film thickness on light emission of CSP WLED was investigated and the results are shown in Fig.7. For the sake of simplicity, the transmittance for the unconverted blue light emit from blue LED and converted yellow light emit from phosphor are denoted as η_{460BT} and η_{460YT} . The transmittance of yellow light emit from yellow LED are denoted as η_{550YT} . The total yellow light emits from phosphor excited by yellow LED are denoted as η_{550YT} .



Fig. 7 Simulation results of (a) Total yellow light emission from phosphor, the transmittance of YAG and YAG@SiO₂ phosphors for (b) yellow light emit from yellow LED (c) converted light emit from phosphor excited by blue light and (d) blue light emit from blue LED

As shown in Fig. 7 (a), when the phosphor is excited by 550nm yellow light, the total amount of yellow light scattered from YAG@SiO₂ phosphor is almost consistent with it from YAG phosphor. It is because SiO₂ almost has no absorption in the visible light range, hence, the absorption of yellow light by SiO₂ is negligible as shown in Fig. 7 (a). As seen from Table 1, the absorption coefficients of SiO₂ at 460nm and 550nm are basically the same, therefore, the absorption of 460nm blue light by the coated 20nm SiO₂ layer is also negligible.

As seen from the results of Fig.5, 550*asy* increase slightly while YAG phosphor was coated by 20nm SiO₂, indicates that under yellow light illumination, more of the light is forward scattered compared with pristine YAG phosphor. Therefore, as seen from Fig.7(b), η_{550YT} of YAG@SiO₂ is slightly higher than that of YAG phosphor. Based on Lambert-Beer's law, more light is absorbed when

the thickness of the phosphor film H increased from 0.05 to 0.3mm, therefore, η_{550YT} of YAG and YAG@SiO₂ decreased as a result.

Fig. 7(c) and (d) show us the transmittance for the converted yellow light (η_{460YT}) and the unconverted blue light (η_{460BT}) excited by blue LED. It shows that η_{460YT} increase but η_{460BT} decrease while the phosphor film thickness increase. This is in accordance with the result of Lambert-Beer's law , while more blue light could be absorbed by phosphors as the phosphor film is thicker, therefore, less unconverted blue light but more converted yellow light emit out. When the phosphor film thickness is the same, η_{460YT} of YAG@SiO₂ is greater than that of YAG. This is due to the fact that YAG@SiO₂ possess higher $460\mu_{abs}$ (see Fig.4(a)), hence more blue light is absorbed by YAG@SiO₂ compared with YAG, accordingly more light is converted into yellow light emission, as many earlier scholars reported [13,24].



Fig. 8 Conversion efficiency of phosphor

Fig. 8 shows the conversion efficiency of YAG and YAG@SiO2 excited by blue LED. As the

thickness of the phosphor film increases, the conversion efficiency of phosphor gradually decreases, it might due to the fact that when the film is too thick or the phosphor concentration is too high, the oversaturated phosphor causes more converted light to be back reflected [21], and less light to be forward reflected. This might cause multiple reflection of the converted light between the phosphor layer and the chip. The multiple reflection result in the high absorption of converted light and decrease of luminous efficiency. However, YAG@SiO₂ has a 1.2% higher conversion efficiency than YAG, which implies that phosphor coating might be an effective way to improve the light efficiency.

In order to generate white light, the luminescence efficiency and true color map of the CSP WLED with different YAG film thickness (H) is simulated. As the thickness of the YAG fluorescent film increases, the luminous efficacy and color temperature of blue LED excited WLED gradually increase. When H is 0.3mm, the luminous efficiency gradually reaches saturation. When H is 0.2mm, the fabricated CSP LED possess a cold white light emission with a CCT of 10066K, color coordinates of (0.2851, 0.2786) (as shown in Fig.11(b)) and a luminous efficacy up to 130.3 lm/W (as shown in Fig.9).



Fig. 9 Influence of YAG fluorescent film thickness on luminous efficiency of YAG WLED

The fluorescent film thickness (H) is fixed at 0.2mm, the influence of SiO₂ coating thickness on the luminous efficiency (LEE) and Correlate Color Temperature (CCT) of CSP WLED are shown in Fig.10. With the increasing of SiO₂ coating thickness, LEE of CSP WLED firstly increase and then decrease. When the coating thickness is 20nm, the luminous efficacy reached the maximum value 138.92 lm/W. This might due to the fact that $460\mu_{abs}$ of YAG@SiO₂ phosphor reaches the highest value while the SiO₂ coating thickness is 20 nm. Under this condition, more blue light emitted from the chip could be absorbed by YAG@SiO₂ phosphor film. More absorption of blue light by the YAG@SiO₂ phosphor, more emission of yellow light, therefore enhanced LEE is obtained.



Fig.10 Influence of coating thickness on LEE and CCT of CSP WLED

Meanwhile, CCT of YAG@SiO₂ WLED decreases when the thickness of SiO₂ coating layer increases from 0 to 20 nm. When the thickness of the SiO₂ coating layer is over 20 nm, the color temperature of YAG@SiO₂ WLED increases sharply. Low color temperature WLED is prefer under working condition. It is found that proper SiO₂ layer thickness endowing YAG@SiO₂ with more absorption of blue light and high output of yellow light, therefore significantly enhance the LEE and decrease the CCT of WLED. The highest value of LEE, 138.92 lm/W, the lowest CCT, 6667K, are achieved at a SiO_2 layer thickness of 20nm. The simulation results above show that proper SiO_2 coating on phosphors is responsible for the enhanced luminous efficacy and lower color temperature of CSP WLED, which is in accordance with the former reports. [23]

Using Monte Carlo method, the quality of white light emission from the YAG and YAG@SiO₂ WLED was evaluated via CIE chromaticity diagram and Luminous flux figure (as shown in Fig.11). The results are listed in Table 2.



Fig. 11 (a) Luminous flux figure of YAG WLED; (b)Luminous flux figure of YAG@SiO₂WLED; (c) Chromaticity color coordinates of YAG and YAG@SiO₂ upon excitation at 460 nm

Ray Tracing method					
Phosphor	LEE	ССТ	CIE	Fluorescence	
	(lm/W)	(K)	(x, y)	conversion efficiency	
YAG	132.11	10066	(0.2851,0.2786)	0.4299	
YAG@SiO ₂	138.92	6637	(0.3110,0.3244)	0.4392	

Table. 2 Optical properties of YAG and YAG@SiO₂ WLEDs Simulated by Monta Carlo Ray Tracing method

When the thickness of fluorescent film is 0.2 mm, SiO₂ coating layer is 20 nm, YAG@SiO₂ WLED shows a light efficiency of 138.92 lm/W, a color temperature of 6637K, and a color coordinate of (0.3110, 0.3244), as shown in Tab.2. Compared with original YAG WLED, higher LEE and lower CCT is achieved in YAG@SiO₂ WLED, which is resulted from enhanced forward scattering and stronger blue light absorption. Meanwhile, the color coordinates of YAG@SiO₂ WLED is closer to the theoretical white point of (0.33, 0.33). This result shows that an ideal white color is almost achieved in YAG@SiO₂ under 460nm blue LED excitation. Meanwhile, proper SiO₂ thin layer coating on YAG significantly enhanced LEE and CCT of WLED, and a good cold white light emission is achieved.

Our simulation gives a theoretical explanation about the reason why proper coating thickness on YAG phosphor endows the CSP WLED with higher luminous efficacy and lower color temperature, hence better luminescence properties.

5. Conclusions

Optical configuration of chip scale packages WLEDs are established by coating YAG or YAG@SiO₂ phosphor film directly on the chip surface. In order to ensure the correct simulation of luminescence properties of the CSP white LED, the specific optical constants including the absorption coefficient μ_{abs} , scattering coefficient μ_{sca} , and anisotropy factor *asy* of YAG and YAG@SiO₂ are calculated based on Mie scattering theory. The dependency of coating thickness of SiO₂ layer and phosphor mass fraction w_f on optical constants μ_{abs} , μ_{sca} and *asy* are investigated. It shows that when the coating thickness is 20 nm, the absorption coefficient increases the most, which is conducive to increase the absorption of blue light, enhance the yellow light emission and eventually improve the luminescence property. The decrease in scattering coefficient is also

conducive to the improvement of luminous efficiency. Numerical results show that Mie theory is effective in predicting the changing tendencies of the optical constants as the mass fraction of phosphor or the coating thickness changes. It makes Mie theory a suitable tool in WLED packaging design. Two color LEDs are used as light sources to simulate the light extraction of YAG and YAG@SiO₂ WLED via Monte Carlo ray tracing method. It implies that SiO₂ coating mainly result in the enhanced absorption of blue light and yellow light converting, hence the higher conversion efficiency for YAG@SiO₂. As the thickness of the fluorescent film is 0.2 mm, with 2 µm YAG@SiO₂ coated by 20 nm SiO₂ layer in it, our WLED gives a light efficiency of 138 lm/W, a color temperature of 6637 K, and a color coordinate of (0.3110, 0.3244), The light conversion efficiency after coating is increased by 1.2% compared with that before coating.

The simulation of photoluminescence property of YAG@SiO₂ WLED can be adapted to various coated phosphors WLED systems, the color quality can be easily tuned by changing the coating thickness, the phosphor film thickness or the mass fraction of phosphor, which have potential use in the future WLED packaging designing.

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References

- H.T. Zhu, X.H. Liu, R.L. Fu, Y.H. Shi, H. Wang, Q.J. He, X.F. Song, Luminous efficiency enhancement of WLEDs via patterned RGB phosphor arrays, J. Lumin. 211 (2019) 1-7.
- [2] Q. He, R. Fu, X. Song, H. Zhu, X. Su, C. You, Tunable luminescence and energy transfer from Ce³⁺ to Dy³⁺ in Ca₃Al₂O₆ host matrix prepared via a facile sol-gel process, J. Alloy. Compd. 810 (2019) 151960.
- [3] B. Sun, X. Jiang, K.-C. Yung, J. Fan, M.G. Pecht, A Review of Prognostic Techniques for High-Power White

LEDs, IEEE Transactions on Power Electronics 32 (2017) 6338-6362.

- [4] M.-H. Chang, D. Das, P.V. Varde, M. Pecht, Light emitting diodes reliability review, Microelectronics Reliability
 52 (2012) 762-782.
- [5] J. Fan, C. Yu, C. Qian, X. Fan, G. Zhang, Thermal/luminescence characterization and degradation mechanism analysis on phosphor-converted white LED chip scale packages, Microelectronics Reliability 74 (2017) 179-185.
- [6] J. Bhardwaj, J.M. Cesaratto, I.H. Wildeson, H. Choy, A. Tandon, W.A. Soer, P.J. Schmidt, B. Spinger, P. Deb,
 O.B. Shchekin, W. Götz, Progress in high-luminance LED technology for solid-state lighting, physica status solidi (a) 214 (2017) 1600826.
- [7] J. Zhong, D. Chen, Y. Zhou, Z. Wan, M. Ding, Z. Ji, Stable and chromaticity-tunable phosphor-in-glass inorganic color converter for high-power warm white light-emitting diode, J. Eur. Ceram. Soc. 36 (2016) 1705-1713.
- [8] H.S. Lee, J.W. Yoo, Yellow phosphors coated with TiO₂ for the enhancement of photoluminescence and thermal stability, Appl. Surf. Sci. 257 (2011) 8355-8359.
- [9] Meiqi Chang, Yanhua Song, Ye Sheng, Jie Chen, H. Zou, Understanding the remarkable luminescence enhancement via SiO₂ coating on TiO₂:Eu³⁺ nanofibers, PCCP 19 (2017) 17063-17074.
- [10] S. Li, Q. Zhu, D. Tang, X. Liu, G. Ouyang, L. Cao, N. Hirosaki, T. Nishimura, Z. Huang, R.-J. Xie, Al₂O₃– YAG:Ce³⁺ composite phosphor ceramic: a thermally robust and efficient color converter for solid state laser lighting, J. Mater. Chem. C 4 (2016) 8648-8654.
- [11] G. Feng, W. Jiang, J. Liu, C. Li, Q. Zhang, L. Miao, Q. Wu, Synthesis and luminescence properties of Al₂O₃@YAG: Ce³⁺ core–shell yellow phosphor for white LED application, Ceram. Int. 44 (2018) 8435-8439.
- [12] G. Li, M. Lv, J. Dai, X. Li, Comparative study on two synthesis methods of core-shell structured SiO₂@Y₂O₃:Eu³⁺ particles and their luminescence properties, Opt. Mater. 46 (2015) 40-44.

- [13] Xiong M, Xi X, Gong H, et al. Effects of SiO₂ coating on luminescence property and thermostability of Sr₂MgSi₂O₇: Eu²⁺, Dy³⁺phosphors[J]. Journal of Sol-Gel Science and Technology, 81 (2017) 894-902.
- [14] Secu M, Cernea M, Secu C E, et al. Structural and optical properties of fluorescent BaFBrEu²⁺@SiO₂ core/shell phosphor heterostructure[J]. Materials Chemistry and Physics, 2015, 151:81-86.
- [15] Han J K, Hirata G A, Talbot J B, Luminescence enhancement of Y₂O₃:Eu³⁺ and Y₂SiO₅:Ce³⁺,Tb³⁺ core particles with SiO2 shells, Materials Science & Engineering B,5 (2011) 436-441.
- [16] Chung E J , Masaki T , Song Y H , et al. Enhancement of thermal quenching properties of a yellow-emitting SiO₂-coated Y3Al5O12:Ce³⁺ phosphor for white light-emitting diode applications[J]. Physica Scripta, 2013, T157(T157):4012.
- [17] Nien Y T , Chen K M , Chen I G. Improved Photoluminescence of Y3Al5O12:Ce Nanoparticles by Silica Coating[J]. Journal of the American Ceramic Society, 2010, 93(6):1688-1691.
- [18] Zhang R J , Yan W P , Ling-Zhi M A . Sol-gel Synthesis of Organic-inorganic Composite Phosphor and Luminescence Properties[J]. Chinese Journal of Luminescence, 2007, 28(1):126-130.
- [19] Mtzler C. MATLAB functions for Mie scattering and absorption. 2002.
- [20] Pfeiffer K , Shestaeva S , Bingel A , et al. Comparative study of ALD SiO₂ thin films for optical applications[J]. Optical Materials Express, 2016, 6(2):660.
- [21] Kraisinger C J , Xu W Q , Snyder M J . Optical properties of undoped and neodymium doped polycrystalline yttrium aluminum garnet[C] Window and Dome Technologies and Materials XVI. 2019.
- [22] Liu Z, Liu S, Wang K, et al. Measurement and Numerical Studies of Optical Properties of YAG:Ce Phosphor for White Light-Emitting Diode Packaging[J]. Applied Optics, 2010, 49(2):247-257.
- [23] Hu R, Fu X, Zou Y, et al. A complementary study to "Toward scatter-free phosphors in white phosphorconverted light-emitting diodes:" comment[J]. Optics Express, 2013, 21(4):5071-3.

- [24] S.M. Rafiaei, S. Kang, Effect of nano-sized SiO₂ on the optical properties of YVO₄:Eu³⁺ phosphors, Compos. Interfaces 24 (2016) 319-333.
- [25] S.M.Kacznarek, G Domianiak-Dzik, W. Ryba-Romanowski et al. Changes in optical properties of Ce:YAG crystals under annealing and irradiation processing. Crystal Research and Technology, 1999, 34: 1031-1036.
- [26] E. Mihokova, M. Nikl, A. Mares et al. Luminescence and scintillation properties of YAG: Ce single crystal and optical ceramics. Journal of Luminescence, 2007, 126: 77-80.
- [27] R. Kasuya, A. Kawano, T. Isobe, H. Kuma, and J. Katano, Characteristic optical properties of transparent color conversion film prepared from YAG: Ce³⁺ nanoparticles, Appl. Phys. Lett, 2007, 91: 111916

Simulation of Optical behavior of YAG:Ce³⁺@SiO₂ phosphor used for chip scale packages WLED

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Abstract

YAG:Ce³⁺ yellow phosphor are particularly used luminescent materials to produce white light in phosphor-converted white LED (pc-WLED). Surface coating of YAG phosphor is the main concern for desired optical performance of the phosphors. Many scholars conducted various experimental analysis on the surface coating of phosphors to improve yellow emission, but the theoretical explanation by which phosphor coating could help improving light efficiency has not yet been studied. In this paper, based on Mie theory, the optical constants such as scattering coefficient, absorption coefficient and asymmetry parameter of YAG:Ce³⁺ phosphor and YAG@SiO₂ (YAG:Ce³⁺ phosphor surface coated with nano-SiO₂ layer) were calculated. An optical configuration of chip scale packages (CSP) WLED was constructed by coupling YAG:Ce³⁺ or YAG@SiO₂ phosphors with a LED laser. Based on the optical parameters calculated by Mie theory, the luminescent properties of YAG:Ce³⁺ and YAG@SiO₂ WLED were simulated by Monte Carlo method. The results showed that a thin SiO₂ coating layer on YAG phosphor result in an overall increase in luminous performances compared with original YAG WLED. The absorption coefficient of phosphor is the main concern affecting the light emission in WLED. Due to the fact that YAG@SiO₂ possess higher $460\mu_{abs}$, it could absorb more blue light than YAG, thereby it has a 1.2% higher conversion efficiency than YAG, finally the enhanced luminous efficiency of YAG@SiO₂ WLED is obtained. The results obtained in this work provides a potential method in future WLED packaging designing.

1. Introduction

White lighting-emitting-diode (WLED) has been widely used in commercial solid lighting applications because of its small size, long life, energy saving, environmentally friendly and high luminous efficiency properties [1, 2]. The most appropriate method to obtain WLED is called phosphor-converted (pc-) WLED. Typically, a pc-WLED is usually fabricated by combining the blue LED chip with YAG:Ce³⁺ phosphors which has acceptable color rendering and robust reliability. Traditionally, a pc-WLED package consists of LED chip, phosphors, lead frame, silicone, substrate and so on [3]. However, more packaging components in WLED package indicate higher failure possibility as well as more space occupation and more weight^[4]. The chip scale package (CSP) technology is developed by covering a thin YAG fluorescent film on a blue LED chip, which could tackle this problem. The advantages of CSP WLED are the increased manufacturing efficiency [5, 6], high packing density and high luminous flux output. In the package, refractive index of silica gel (1.41) is lower than that of YAG: Ce^{3+} crystal (1.84) in the thin phosphor film, therefore, more yellow light is absorbed by phosphor particle due to the total internal reflection (TIR), luminous efficiency of the CSP WLED decreases accordingly. At the same time, the refractive index difference between phosphor and silica gel leads to light scattering at the interface, which also results in the blue light reflection loss and the decrease of luminous efficiency [7]. More recently, some studies try to solve the problem by coating a dielectric layer with suitable refractive index on the phosphor. This refers to coating one or more

layers of oxide material on the surface of the phosphor particles, such as TiO₂ [8, 9], Al₂O₃ [10, 11] and SiO₂ [12, 13]. The oxide material coating on the phosphors with matched refractive index could reduce the yellow light absorption by TIR, decrease the blue light reflection loss at the interface, in the end, improve the luminous efficiency of WLED. Among them, SiO₂ is widely used due to its optical transparency, tunable size [14] and low cost [15]. It has been have concluded that SiO₂-coated YAG phosphor limits the thermal quenching properties [16, 17]. Therefore, YAG phosphor coated with SiO₂ layer(YAG@SiO₂) could be considered as a good candidate for white light-emitting diode applications[18]. Many scholars conducted experimental analysis on phosphor coating, most of the studies focus on the influence of oxide layer microstructure on the luminous efficiency of WLED evaluated by photoluminescence spectra (PL spectra), but no one go deep into the light efficiency enhancement mechanism investigations. Few researchers seriously considered how the variation of light absorption and scattering of oxide layer coated phosphor affect the light extraction of WLED. Meanwhile, the optical parameters such as scattering coefficient (μ_{sca}), absorption coefficient (μ_{abs}) and anisotropy parameter (μ_{abs}) of the coated phosphors also change as well. Actually, precise optical constants of coated phosphor are indispensable in the numerical simulation of the luminescent property of WLED. However, few research discussed about this, to the best of our knowledge.

In this paper, the YAG:Ce³⁺ and YAG@SiO₂ were chosen as the optical simulation target. Firstly, consider the YAG and YAG@SiO₂ phosphor as spheres, the optical constants of these two phosphors were calculated based on Mie theory. Secondly, based on the optical constants of YAG and YAG@SiO₂ phosphor obtained, the luminescence performances of YAG and YAG@SiO₂ CSP WLED were simulated based on Monte Carlo method. Thirdly, in view of the foregoing results, we hold the opinion that this method can be extended to other coating layers and phosphor systems and it is helpful to

decrease the amount of experiments significantly.

2. Description of the configuration of CSP-packaged WLED

The configuration of CSP-packaged WLED is constructed as shown in Fig. 1. In CSP LEDs, blue LED chips are mostly covered with yellow YAG fluorescent film to generate white emission (as shown in Fig.1 (e)). The YAG fluorescent film (as shown in Fig. 1(d)) is composed of phosphor particles and silica gel which are mixed in certain proportion. The optical parameters of YAG phosphor film determines the light-emitting behavior (luminous efficiency, color temperature, etc.) of the final CSP WLED. After YAG phosphor is coated by SiO₂ layer (as shown in Fig.1(b), the optical constants of YAG@SiO₂ change accordingly, which can be calculated via Mie theory.



Fig. 1 Schematic diagram of (a) YAG phosphor particle (YAG); (b) YAG phosphor coated with SiO₂ (YAG@SiO₂); (c) YAG@SiO₂ cross sectional view; (d) YAG film (e) CSP WLED

We assume that spherical YAG and YAG@SiO₂ (YAG phosphor coated with a 10~40 nm SiO₂ layer) phosphor are evenly distributed in this film (as showed in Fig.1 (a) and (b)), where the yellow region is YAG phosphor and the white one is SiO₂ layer (as shown in Fig.1(b)). The sectional view of YAG@SiO₂ is shown in Fig. 1(c), in which signal 1,2,3 represent the fluorescent material (YAG),

coating layer material (SiO₂) and silicone respectively, a and b represent the radius of YAG and YAG@SiO₂ phosphor, respectively.

To be convenient, we assume that, first of all, the nano-SiO₂ layer coated on the surface of YAG phosphor is optically transparent in the visible light range. Secondly, YAG and YAG@SiO₂ phosphor are ideal smooth spheres, meanwhile, SiO₂ layer are tightly contacted with YAG phosphor in YAG@SiO₂. The schematic diagram of phosphor film is shown in Fig. 1 (d). The phosphor film is consisted of phosphor particles and silicone, while the YAG phosphor particle size is set as 2 μ m in this paper.

3. Calculation of optical constants via Mie theory

Before starting the optical simulation of WLED, the optical constants of YAG@SiO₂ phosphor need to be calculated via Mie theory [19]. Following is the process of the optical constants calculation. YAG phosphor can emit yellow light while being excited by blue light, thereby, 460 nm and 550 nm incident light as the light resource are chosen in the calculation. Algorithm process of optical parameters calculation is shown in Fig. 2.



Fig. 2 Algorithm process of optical parameters calculation

Based on the size of YAG and YAG@SiO₂ phosphor (a, b), the refractive index of YAG(n_{YAG}), SiO₂(n_{SiO_2}) and silicone(n_{sil}), the incident light wavelength in the ambient medium(λ), the scattering efficiency(Q_{sca}), absorption efficiency(Q_{abs}) and asymmetry parameters(asy) of YAG or YAG@SiO₂ phosphor can be calculated via Mie theory. Furthermore, the absorption coefficient (μ_{abs}), scattering coefficient(μ_{sca}) and asymmetry parameters (asy) of YAG and YAG@SiO₂ phosphor can also be calculated by Mie theory. The specific calculation process is illustrated below.

According to Mie scattering theory, x, y are the size constants, which can be calculated by equations (1) and (2):

$$x = k \times a \tag{1}$$

$$y = k \times b \tag{2}$$

As shown in Fig. 1(c), *a* is the radius of YAG phosphor and *b* is the overall radius of YAG@SiO₂. In addition, *b*-*a* is the coating thickness, *k* is the wave number in the ambient medium (silicone gel) which can be described by equation (3):

$$k = \frac{2\pi n_{sil}}{\lambda} \tag{3}$$

where λ is the incident light wavelength in the ambient medium. n_{sil} is silicone gel's refractive index. m_1 is the refractive index of YAG phosphor relative to the ambient medium, m_2 is the refractive index of SiO₂ coating relative to the ambient medium. Silica gel is the ambient medium in LED packaging. Here the following equations (4) and (5) give the expression of m_1 and m_2 .

$$m_{\rm I} = \frac{n_{YAG}}{n_{_{sil}}} \tag{4}$$

$$m_2 = \frac{n_{sio_2}}{n_{sil}} \tag{5}$$

YAG phosphor and SiO₂ both have scattering and absorption properties, so their refractive indices have a complex form:

$$n_{YAG} = n_{YAG} - n_{YAG} \times i$$
(6)

$$n_{SiO_2} = n_{SiO_2} - n_{SiO_2} \times i \tag{7}$$

where n' and n'' are the refractive index and extinction coefficient. The relationship between n' and n'' is shown as following:

$$n'' = \alpha \lambda / 4\pi n' \tag{8}$$

where α is absorption coefficient, λ is the incident wavelength.

Table 1 lists the parameters of involved material. Most of the light can directly pass through the SiO₂ layer, the scattering effect is not obvious, and the scattering coefficient of SiO₂ is almost 0. As showed in Table 1, the transmittance(T) of SiO₂ is close to 1 which means SiO₂ have good optical transparency. Meantime, SiO₂ almost has no absorption in the visible light range. The absorption coefficient (α), refractive index(n) and extinction coefficient(n) were shown in table1 which can be used in calculation.

 Table 1 parameters of YAG and SiO₂[20-22]

Components	parameters		
SiO ₂ layer	$\lambda = 460 \text{ nm}, \ n'_{SiO_2} = 1.484, \ n''_{SiO_2} = 4.00\text{E-}07$	$\alpha = 0.162 \text{ cm}^{-1}, T = 0.987$,	
	$\lambda = 550 \text{ nm}, \ \dot{n_{siO_2}} = 1.479, \ \dot{n_{siO_2}} = 4.00\text{E-}07$	$\alpha = 0.1352 \text{ cm}^{-1}, T = 0.991$	
YAG	$\lambda = 460 \text{ nm}, \ n_{YAG} = 1.851, \ n_{YAG} = 5.12\text{E-}04$	$\alpha = 258.897 \text{ cm}^{-1}$	
	$\lambda = 550 \text{ nm}, \ n'_{YAG} = 1.839, \ n''_{YAG} = 1.31\text{E}-05$	$\alpha = 5.984 \text{ cm}^{-1}$	

Here the following equations (9) to (12) give the expression for A_n , B_n , D_n and m, where ψ_n and χ_n are Bessel functions, m is the refractive index with respect to the ambient medium, D_n is the logarithmic derivative of ψ_n .

$$A_{n} = \psi_{n}(m_{2}x) \frac{mD_{n}(m_{1}x) - D_{n}(m_{2}x)}{mD_{n}(m_{1}x)\chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(9)

$$B_{n} = \psi_{n}(m_{2}x) \frac{D_{n}(m_{1}x) / m - D_{n}(m_{2}x)}{D_{n}(m_{1}x) \chi_{n}(m_{2}x) - \chi_{n}'(m_{2}x)}$$
(10)

$$m = \frac{m_2}{m_1} \tag{11}$$

$$D_n = \frac{\psi_n'(mx)}{\psi_n(mx)} \tag{12}$$

Here the following equations (13) and (14) give the expression for D_n and G_n .

$$\tilde{D}_{n} = \frac{D_{n}(m_{2}y) - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{A_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$

$$\tilde{G}_{n} = \frac{D_{n}(m_{2}y) - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}{1 - \frac{B_{n}\chi_{n}(m_{2}y)}{\psi_{n}(m_{2}y)}}$$
(13)

In Mie scattering theory, a_n and b_n are the Mie expansion scattering coefficients. They could be expressed by equations (15) and (16):

$$a_{n} = \frac{(D_{n}/m_{2} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(\tilde{D}_{n}/m_{2} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(15)

$$b_{n} = \frac{(m_{2}\tilde{G}_{n} + n/y)\psi_{n}(y) - \psi_{n-1}(y)}{(m_{2}\tilde{G}_{n} + n/y)\xi_{n}(y) - \xi_{n-1}(y)}$$
(16)

where ξ_n is Hankel functions of second kind.

According to Mie scattering theory, the extinction efficiency Q_{ext} , the scattering efficiency Q_{sca} , the absorption efficiency Q_{abs} , and the asymmetry parameter *asy* of optical medium are calculated according to equations (17) to (20) [22].

$$Q_{sca} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) \left(\left| a_n \right|^2 + \left| b_n \right|^2 \right)$$
(17)

$$Q_{ext} = \frac{2}{x^2} \sum_{n=1}^{\infty} (2n+1) Re(a_n + b_n)$$
(18)

$$Q_{abs} = Q_{ext} - Q_{sca} \tag{19}$$

$$asy = \frac{4}{x^2} \left\{ \sum_{n=1}^{\infty} Re(a_n a_{(n+1)}^* + b_n b_{(n+1)}^*) \right\} / Q_{sca}$$
(20)

Among them, R_e represents the real part of the complex number, * represents the transpose.

Based on the results of Q_{sca} , and Q_{abs} , the absorption coefficient (μ_{abs}) and scattering coefficient (μ_{sca}) of YAG and YAG@SiO₂ are calculated according to equations (21) and (22)[22].

$$\mu_{abs} = Q_{abs} A v_f \cdot (1/V) = 3Q_{abs} v_f / 4b$$
⁽²¹⁾

$$\mu_{sca} = Q_{sca} A v_f \cdot (1/V) = 3Q_{sca} v_f / 4b$$
(22)

where *A* is the geometrical cross area of the phosphor particle, *V* is the volume of the particle , v_f is the volume fraction of YAG or YAG@SiO₂. For YAG@SiO₂, v_f is described by equation (23):

$$v_{f} = \frac{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}}}{m_{_{YAG}} / \rho_{_{YAG}} + m_{_{SiO_{2}}} / \rho_{_{SiO_{2}}} + m_{_{sil}} / \rho_{_{sil}}}$$
(23)

 $m_{_{YAG}}$ is the mass of YAG phosphor, $m_{_{SIO_2}}$ is the mass of SiO₂, $m_{_{Sil}}$ is the mass of silica gel, $\rho_{_{YAG}}$ is the density of YAG phosphor, $\rho_{_{SIO_2}}$ is the density of SiO₂ and $\rho_{_{sil}}$ is the density of silica gel. In this calculation, $\rho_{_{YAG}}$, $\rho_{_{SIO_2}}$ and $\rho_{_{sil}}$ are set as 4.6, 2.2 and 1.1 g/cm³, respectively. In practical applications, mass fraction of YAG phosphor (w_f) in phosphor film is more commonly used instead of the volume fraction of phosphor (v_f), it is expressed as following:

$$w_f = \frac{m_{_{YAG}} + m_{_{SIO_2}}}{m_{_{YAG}} + m_{_{SIO_2}} + m_{_{SII}}}$$
(24)

The absorption coefficient (μ_{abs}), scattering coefficient (μ_{sca}) and asymmetry parameter (*asy*) of the phosphor film affect the light absorption and scattering, therefore, show great influence on the light extraction and the final luminous efficiency of WLED. Concentration of YAG phosphors and a, b values are the main factors that affect the optical constants μ_{abs} , μ_{sca} and *asy* of the final fluorescent film. The influence of coating thickness (b-a), mass fraction of the phosphor (*w_f*) and incident light wavelength (λ) on μ_{abs} , μ_{sca} and *asy* of phosphor film are discussed through Mie scattering theory calculation. Generally, 460nm blue light excites YAG phosphor and generates yellow light with a dominant wavelength of 550nm. For simplicity, 460 μ_{abs} and 550 μ_{abs} denote the absorption coefficient of phosphors excited by 460nm and 550nm incident light, respectively. 460 μ_{sca} and 550 μ_{sca} denote the scattering coefficient of phosphors excited by 460nm and 550nm incident light, respectively.



Fig. 3 μ_{abs} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light

As shown in Fig.3 (a), $460\mu_{abs}$ increased as the thickness of SiO₂ layer increased from 0 to 20 nm, and then decreased when continue increasing the thickness to 40 nm. It is obviously noticed that $460\mu_{abs}$ reached the highest value when the phosphor coating is 20nm. Compared with pristine phosphor , after being coated with nano-SiO₂ layer, the photons mainly transmit the SiO₂ layer via increasing the absorption of blue light due to the low refractive index of SiO₂ and then get to the phosphor surface , therefore, the effective excitation absorption of the phosphor via the SiO₂ layer occurred [9]. Based on Lambert-Beer's law, the transmitted light through a layer of coating is inversely proportional to the thickness of coating material. Although the coating layer can decrease the reflectance (which enhances the luminescence properties), while the quantity of light escaping from phosphor is reduced in much thicker layer [13]. Therefore, in our research, when the coating thickness is 20nm, the absorption of 460nm blue light by YAG@ SiO₂ find the maximum value. Our calculation is entirely consistent with previous reports [13,24].

The incident light absorption coefficient $460\mu_{abs}$ and $550\mu_{abs}$ are not in the same order of magnitude as shown in Fig.3. $550\mu_{abs}$ is much smaller than $460\mu_{abs}$. Meanwhile, as shown in Fig.3 (b), for 550nm incident light, the thickness of the SiO₂ coating layers had little influence on the

absorption coefficient of YAG phosphor film. All these are due to the fact that YAG phosphor crystals show quite different absorption coefficients while excited by blue or yellow light [25, 26], for blue light the absorption coefficient is 3-8 mm⁻¹, however it is only 0.1-0.5 mm⁻¹ for yellow light. Our calculation is in accordance with the experimental results.

While considering about the influence of mass fraction of the phosphor (w_f) on $460\mu_{abs}$ or $550\mu_{abs}$, as w_f increased from 0.1 to 0.7, there are more phosphor particles in the fluorescent film, the absorption of incident light increased, thus, $460\mu_{abs}$ or $550\mu_{abs}$ increased accordingly.



Fig.4 μ_{sca} of phosphor film (a) excited by 460nm blue light (b) excited by 550nm yellow light

As shown in Fig. 4, when the thickness of the SiO₂ coating layer increased, $460\mu_{sca}$ and $550\mu_{sca}$ of YAG@SiO₂ both slightly decreased, illustrated that less light energy is lost by scattering and more energy can be used for illumination by coating thicker SiO₂ layer. It is noting that using phosphors with smaller scattering coefficient could be a way to suppress the scattering loss. The results indicated that coating of SiO₂ suppressed the scattering loss in a certain extent [22]. While increase w_f of phosphor from 0.1 to 0.7, more light was scattered because there is more phosphor in the fluorescent film. Comparing the results in Fig.4 (a) and (b), it is found that the variation of μ_{sca} is very small when the incident light changes from blue light to yellow light. This indicates that the scattering

property of coated phosphors are similar with uncoated one for different light, the big difference of absorption property between coated phosphor and uncoated one might be the main reason that affect the light extraction and luminous efficiency of WLED.





As shown in Fig.5, while excited by 460 nm or 550 nm incident light, *asy* of YAG and YAG@SiO₂ phosphor were positive, which meant under this condition, the number of forward scattered lights were greater than the number of backscattered lights [23]. While the coating thickness increased to 20nm, *asy* (460 nm or 550 nm excitation) increased a little, indicated the increasing of forward scattering. When coating thickness exceeded 20 nm, *asy* of YAG@SiO₂ had opposite trends while excited by 460 nm blue light or 550 nm yellow light. The increase of *asy*₄₆₀ indicated that the scattered light concentrated in smaller forward scattering angle, which resulted in an increase in the number of forward scattered light. Reversely, the decrease of *asy*₅₅₀ meant that more light was backscattered, absorbed and converted into heat loss. Herein, the backscattering loss of the emission from phosphor particles decreased the external quantum efficiency of the white LED [27]. If there are more forward scattered light existed in the packaged WLED, the luminous efficiency is improved as a result. The results in Fig.5 shows that the value of *asy*₅₅₀ and *asy*₄₆₀ is very close. When coating thickness changes,

there is no great variation in *asy*. However, based on the previous results, it is clear that scattering property of phosphors is not the main reason for light extraction in packaged WLED. The tiny difference between *asy*₅₅₀ and *asy*₄₆₀ almost have no effect on light extraction in packaged WLED.

4. Optical simulation of CSP-packaged WLED

In most commercial optical software such as Light Tools and Trace Pro, the phosphor scattering is normally treated as Mie scattering to bring about the optical simulation of white LED packaging. The precise optical constants calculation via Mie theory could afford necessary supports for the optical simulation in LED packaging design.

Depend on these obtained optical constants μ_{abs} , μ_{sca} and *asy*, we carried out the photoluminescence property simulation for YAG and YAG@SiO₂ WLED by Monte Carlo ray tracing method. The configuration of CSP-packaged WLED is given in Fig.6. The phosphor film is coated on the surface of the flip chip LED. The CSP chip is a 1 W blue LED chip or yellow LED chip (SAMSUNG LM101B) with dimension of 1mm×1mm×H mm, while H denotes the phosphor film thickness. The receiving surface (Receiver F) is assumed as a perfect absorber which collects blue light emitted from the blue LED chip and yellow light emitted from YAG or YAG@SiO₂ phosphor. To simplify the simulation, the radius of YAG particles is fixed at 2µm, coating thickness of YAG@SiO₂ is set at 20nm, mass fraction of the phosphor (*w*) in phosphor film is set at 0.7.


Fig.6 Configuration of Chip-Scale-Packaged (CSP) WLED

Generally, the most important thing in WLED packaging is the absorption and scattering properties of YAG phosphor for blue light emit from the chip and the yellow light emit from YAG phosphor itself. When the phosphor is excited by 460 nm blue light, the transmitted light is divided into two parts, unchanged blue light and converted yellow light. For 550 nm yellow light excitation, since no converted light is emitted from the phosphor film, the transmitted light is sorted as the yellow light. In this simulation, two 1W color LEDs with peak wavelength of 460 and 550nm are used as the light sources, coating thickness of YAG@SiO₂ is fixed at 20nm and the thickness of the phosphor film changes from 0.05 to 0.30 mm. The influence of the phosphor film thickness on light emission of CSP WLED was investigated and the results are shown in Fig.7. For the sake of simplicity, the transmittance for the unconverted blue light emit from blue LED and converted yellow light emit from phosphor are denoted as η_{460BT} and η_{460YT} . The transmittance of yellow light emit from yellow LED are denoted as η_{550YT} . The total yellow light emits from phosphor excited by yellow LED are denoted as η_{550YT} .



Fig. 7 Simulation results of (a) Total yellow light emission from phosphor, the transmittance of YAG and YAG@SiO₂ phosphors for (b) yellow light emit from yellow LED (c) converted light emit from phosphor excited by blue light and (d) blue light emit from blue LED

As shown in Fig. 7 (a), when the phosphor is excited by 550nm yellow light, the total amount of yellow light scattered from YAG@SiO₂ phosphor is almost consistent with it from YAG phosphor. It is because SiO₂ almost has no absorption in the visible light range, hence, the absorption of yellow light by SiO₂ is negligible as shown in Fig. 7 (a). As seen from Table 1, the absorption coefficients of SiO₂ at 460nm and 550nm are basically the same, therefore, the absorption of 460nm blue light by the coated 20nm SiO₂ layer is also negligible.

As seen from the results of Fig.5, 550*asy* increase slightly while YAG phosphor was coated by 20nm SiO₂, indicates that under yellow light illumination, more of the light is forward scattered compared with pristine YAG phosphor. Therefore, as seen from Fig.7(b), η_{550YT} of YAG@SiO₂ is slightly higher than that of YAG phosphor. Based on Lambert-Beer's law, more light is absorbed when

the thickness of the phosphor film H increased from 0.05 to 0.3mm, therefore, η_{550YT} of YAG and YAG@SiO₂ decreased as a result.

Fig. 7(c) and (d) show us the transmittance for the converted yellow light (η_{460YT}) and the unconverted blue light (η_{460BT}) excited by blue LED. It shows that η_{460YT} increase but η_{460BT} decrease while the phosphor film thickness increase. This is in accordance with the result of Lambert-Beer's law , while more blue light could be absorbed by phosphors as the phosphor film is thicker, therefore, less unconverted blue light but more converted yellow light emit out. When the phosphor film thickness is the same, η_{460YT} of YAG@SiO₂ is greater than that of YAG. This is due to the fact that YAG@SiO₂ possess higher $460\mu_{abs}$ (see Fig.4(a)), hence more blue light is absorbed by YAG@SiO₂ compared with YAG, accordingly more light is converted into yellow light emission, as many earlier scholars reported [13,24].



Fig. 8 Conversion efficiency of phosphor

Fig. 8 shows the conversion efficiency of YAG and YAG@SiO2 excited by blue LED. As the

thickness of the phosphor film increases, the conversion efficiency of phosphor gradually decreases, it might due to the fact that when the film is too thick or the phosphor concentration is too high, the oversaturated phosphor causes more converted light to be back reflected [21], and less light to be forward reflected. This might cause multiple reflection of the converted light between the phosphor layer and the chip. The multiple reflection result in the high absorption of converted light and decrease of luminous efficiency. However, YAG@SiO₂ has a 1.2% higher conversion efficiency than YAG, which implies that phosphor coating might be an effective way to improve the light efficiency.

In order to generate white light, the luminescence efficiency and true color map of the CSP WLED with different YAG film thickness (H) is simulated. As the thickness of the YAG fluorescent film increases, the luminous efficacy and color temperature of blue LED excited WLED gradually increase. When H is 0.3mm, the luminous efficiency gradually reaches saturation. When H is 0.2mm, the fabricated CSP LED possess a cold white light emission with a CCT of 10066K, color coordinates of (0.2851, 0.2786) (as shown in Fig.11(b)) and a luminous efficacy up to 130.3 lm/W (as shown in Fig.9).



Fig. 9 Influence of YAG fluorescent film thickness on luminous efficiency of YAG WLED

The fluorescent film thickness (H) is fixed at 0.2mm, the influence of SiO₂ coating thickness on the luminous efficiency (LEE) and Correlate Color Temperature (CCT) of CSP WLED are shown in Fig.10. With the increasing of SiO₂ coating thickness, LEE of CSP WLED firstly increase and then decrease. When the coating thickness is 20nm, the luminous efficacy reached the maximum value 138.92 lm/W. This might due to the fact that $460\mu_{abs}$ of YAG@SiO₂ phosphor reaches the highest value while the SiO₂ coating thickness is 20 nm. Under this condition, more blue light emitted from the chip could be absorbed by YAG@SiO₂ phosphor film. More absorption of blue light by the YAG@SiO₂ phosphor, more emission of yellow light, therefore enhanced LEE is obtained.



Fig.10 Influence of coating thickness on LEE and CCT of CSP WLED

Meanwhile, CCT of YAG@SiO₂ WLED decreases when the thickness of SiO₂ coating layer increases from 0 to 20 nm. When the thickness of the SiO₂ coating layer is over 20 nm, the color temperature of YAG@SiO₂ WLED increases sharply. Low color temperature WLED is prefer under working condition. It is found that proper SiO₂ layer thickness endowing YAG@SiO₂ with more absorption of blue light and high output of yellow light, therefore significantly enhance the LEE and decrease the CCT of WLED. The highest value of LEE, 138.92 lm/W, the lowest CCT, 6667K, are achieved at a SiO_2 layer thickness of 20nm. The simulation results above show that proper SiO_2 coating on phosphors is responsible for the enhanced luminous efficacy and lower color temperature of CSP WLED, which is in accordance with the former reports. [23]

Using Monte Carlo method, the quality of white light emission from the YAG and YAG@SiO₂ WLED was evaluated via CIE chromaticity diagram and Luminous flux figure (as shown in Fig.11). The results are listed in Table 2.



Fig. 11 (a) Luminous flux figure of YAG WLED; (b)Luminous flux figure of YAG@SiO₂WLED; (c) Chromaticity color coordinates of YAG and YAG@SiO₂ upon excitation at 460 nm

Ray Tracing method				
Phosphor	LEE	ССТ	CIE	Fluorescence
	(lm/W)	(K)	(x, y)	conversion efficiency
YAG	132.11	10066	(0.2851,0.2786)	0.4299
YAG@SiO ₂	138.92	6637	(0.3110,0.3244)	0.4392

Table. 2 Optical properties of YAG and YAG@SiO₂ WLEDs Simulated by Monta Carlo Ray Tracing method

When the thickness of fluorescent film is 0.2 mm, SiO₂ coating layer is 20 nm, YAG@SiO₂ WLED shows a light efficiency of 138.92 lm/W, a color temperature of 6637K, and a color coordinate of (0.3110, 0.3244), as shown in Tab.2. Compared with original YAG WLED, higher LEE and lower CCT is achieved in YAG@SiO₂ WLED, which is resulted from enhanced forward scattering and stronger blue light absorption. Meanwhile, the color coordinates of YAG@SiO₂ WLED is closer to the theoretical white point of (0.33, 0.33). This result shows that an ideal white color is almost achieved in YAG@SiO₂ under 460nm blue LED excitation. Meanwhile, proper SiO₂ thin layer coating on YAG significantly enhanced LEE and CCT of WLED, and a good cold white light emission is achieved.

Our simulation gives a theoretical explanation about the reason why proper coating thickness on YAG phosphor endows the CSP WLED with higher luminous efficacy and lower color temperature, hence better luminescence properties.

5. Conclusions

Optical configuration of chip scale packages WLEDs are established by coating YAG or YAG@SiO₂ phosphor film directly on the chip surface. In order to ensure the correct simulation of luminescence properties of the CSP white LED, the specific optical constants including the absorption coefficient μ_{abs} , scattering coefficient μ_{sca} , and anisotropy factor *asy* of YAG and YAG@SiO₂ are calculated based on Mie scattering theory. The dependency of coating thickness of SiO₂ layer and phosphor mass fraction w_f on optical constants μ_{abs} , μ_{sca} and *asy* are investigated. It shows that when the coating thickness is 20 nm, the absorption coefficient increases the most, which is conducive to increase the absorption of blue light, enhance the yellow light emission and eventually improve the luminescence property. The decrease in scattering coefficient is also

conducive to the improvement of luminous efficiency. Numerical results show that Mie theory is effective in predicting the changing tendencies of the optical constants as the mass fraction of phosphor or the coating thickness changes. It makes Mie theory a suitable tool in WLED packaging design. Two color LEDs are used as light sources to simulate the light extraction of YAG and YAG@SiO₂ WLED via Monte Carlo ray tracing method. It implies that SiO₂ coating mainly result in the enhanced absorption of blue light and yellow light converting, hence the higher conversion efficiency for YAG@SiO₂. As the thickness of the fluorescent film is 0.2 mm, with 2 µm YAG@SiO₂ coated by 20 nm SiO₂ layer in it, our WLED gives a light efficiency of 138 lm/W, a color temperature of 6637 K, and a color coordinate of (0.3110, 0.3244), The light conversion efficiency after coating is increased by 1.2% compared with that before coating.

The simulation of photoluminescence property of YAG@SiO₂ WLED can be adapted to various coated phosphors WLED systems, the color quality can be easily tuned by changing the coating thickness, the phosphor film thickness or the mass fraction of phosphor, which have potential use in the future WLED packaging designing.

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References

- H.T. Zhu, X.H. Liu, R.L. Fu, Y.H. Shi, H. Wang, Q.J. He, X.F. Song, Luminous efficiency enhancement of WLEDs via patterned RGB phosphor arrays, J. Lumin. 211 (2019) 1-7.
- [2] Q. He, R. Fu, X. Song, H. Zhu, X. Su, C. You, Tunable luminescence and energy transfer from Ce³⁺ to Dy³⁺ in Ca₃Al₂O₆ host matrix prepared via a facile sol-gel process, J. Alloy. Compd. 810 (2019) 151960.
- [3] B. Sun, X. Jiang, K.-C. Yung, J. Fan, M.G. Pecht, A Review of Prognostic Techniques for High-Power White

LEDs, IEEE Transactions on Power Electronics 32 (2017) 6338-6362.

- [4] M.-H. Chang, D. Das, P.V. Varde, M. Pecht, Light emitting diodes reliability review, Microelectronics Reliability
 52 (2012) 762-782.
- [5] J. Fan, C. Yu, C. Qian, X. Fan, G. Zhang, Thermal/luminescence characterization and degradation mechanism analysis on phosphor-converted white LED chip scale packages, Microelectronics Reliability 74 (2017) 179-185.
- [6] J. Bhardwaj, J.M. Cesaratto, I.H. Wildeson, H. Choy, A. Tandon, W.A. Soer, P.J. Schmidt, B. Spinger, P. Deb,
 O.B. Shchekin, W. Götz, Progress in high-luminance LED technology for solid-state lighting, physica status solidi (a) 214 (2017) 1600826.
- [7] J. Zhong, D. Chen, Y. Zhou, Z. Wan, M. Ding, Z. Ji, Stable and chromaticity-tunable phosphor-in-glass inorganic color converter for high-power warm white light-emitting diode, J. Eur. Ceram. Soc. 36 (2016) 1705-1713.
- [8] H.S. Lee, J.W. Yoo, Yellow phosphors coated with TiO₂ for the enhancement of photoluminescence and thermal stability, Appl. Surf. Sci. 257 (2011) 8355-8359.
- [9] Meiqi Chang, Yanhua Song, Ye Sheng, Jie Chen, H. Zou, Understanding the remarkable luminescence enhancement via SiO₂ coating on TiO₂:Eu³⁺ nanofibers, PCCP 19 (2017) 17063-17074.
- [10] S. Li, Q. Zhu, D. Tang, X. Liu, G. Ouyang, L. Cao, N. Hirosaki, T. Nishimura, Z. Huang, R.-J. Xie, Al₂O₃– YAG:Ce³⁺ composite phosphor ceramic: a thermally robust and efficient color converter for solid state laser lighting, J. Mater. Chem. C 4 (2016) 8648-8654.
- [11] G. Feng, W. Jiang, J. Liu, C. Li, Q. Zhang, L. Miao, Q. Wu, Synthesis and luminescence properties of Al₂O₃@YAG: Ce³⁺ core–shell yellow phosphor for white LED application, Ceram. Int. 44 (2018) 8435-8439.
- [12] G. Li, M. Lv, J. Dai, X. Li, Comparative study on two synthesis methods of core-shell structured SiO₂@Y₂O₃:Eu³⁺ particles and their luminescence properties, Opt. Mater. 46 (2015) 40-44.

- [13] Xiong M, Xi X, Gong H, et al. Effects of SiO₂ coating on luminescence property and thermostability of Sr₂MgSi₂O₇: Eu²⁺, Dy³⁺phosphors[J]. Journal of Sol-Gel Science and Technology, 81 (2017) 894-902.
- [14] Secu M, Cernea M, Secu C E, et al. Structural and optical properties of fluorescent BaFBrEu²⁺@SiO₂ core/shell phosphor heterostructure[J]. Materials Chemistry and Physics, 2015, 151:81-86.
- [15] Han J K, Hirata G A, Talbot J B, Luminescence enhancement of Y₂O₃:Eu³⁺ and Y₂SiO₅:Ce³⁺,Tb³⁺ core particles with SiO2 shells, Materials Science & Engineering B,5 (2011) 436-441.
- [16] Chung E J , Masaki T , Song Y H , et al. Enhancement of thermal quenching properties of a yellow-emitting SiO₂-coated Y3Al5O12:Ce³⁺ phosphor for white light-emitting diode applications[J]. Physica Scripta, 2013, T157(T157):4012.
- [17] Nien Y T, Chen K M, Chen I G. Improved Photoluminescence of Y3Al5O12:Ce Nanoparticles by Silica
- [18] Zhang R J , Yan W P , Ling-Zhi M A . Sol-gel Synthesis of Organic-inorganic Composite Phosphor and Luminescence Properties[J]. Chinese Journal of Luminescence, 2007, 28(1):126-130.
- [19] Mtzler C . MATLAB functions for Mie scattering and absorption. 2002.
- [20] Pfeiffer K , Shestaeva S , Bingel A , et al. Comparative study of ALD SiO₂ thin films for optical applications[J]. Optical Materials Express, 2016, 6(2):660.
- [21] Kraisinger C J , Xu W Q , Snyder M J . Optical properties of undoped and neodymium doped polycrystalline yttrium aluminum garnet[C] Window and Dome Technologies and Materials XVI. 2019.
- [22] Liu Z, Liu S, Wang K, et al. Measurement and Numerical Studies of Optical Properties of YAG:Ce Phosphor for White Light-Emitting Diode Packaging[J]. Applied Optics, 2010, 49(2):247-257.
- [23] Hu R, Fu X , Zou Y , et al. A complementary study to "Toward scatter-free phosphors in white phosphorconverted light-emitting diodes:" comment[J]. Optics Express, 2013, 21(4):5071-3.

- [24] S.M. Rafiaei, S. Kang, Effect of nano-sized SiO₂ on the optical properties of YVO₄:Eu³⁺ phosphors, Compos. Interfaces 24 (2016) 319-333.
- [25] S.M.Kacznarek, G Domianiak-Dzik, W. Ryba-Romanowski et al. Changes in optical properties of Ce:YAG crystals under annealing and irradiation processing. Crystal Research and Technology, 1999, 34: 1031-1036.
- [26] E. Mihokova, M. Nikl, A. Mares et al. Luminescence and scintillation properties of YAG: Ce single crystal and optical ceramics. Journal of Luminescence, 2007, 126: 77-80.
- [27] R. Kasuya, A. Kawano, T. Isobe, H. Kuma, and J. Katano, Characteristic optical properties of transparent color conversion film prepared from YAG: Ce³⁺ nanoparticles, Appl. Phys. Lett, 2007, 91: 111916

Declaration of interests

 \boxtimes The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

□ The authors declare the following financial interests/personal relationships which may be considered as potential competing interests:

Declaration of Interest Statement

We declare that we have no financial and personal relationships with other people or organizations that can inappropriately influence our work, there is no professional or other personal interest of any nature or kind in any product, service and/or company that could be construed as influencing the position presented in, or the review of, the manuscript entitled "Simulation of Optical behavior of YAG:Ce³⁺@SiO₂ phosphor used for chip scale packages WLED".